



Sample &

Buy





DLP9000

DLPS036B-SEPTEMBER 2014-REVISED OCTOBER 2016

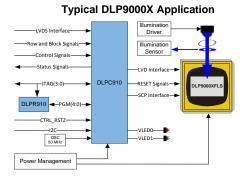
DLP9000 Family of 0.9 WQXGA Type A DMDs

Features 1

Texas

INSTRUMENTS

- High Resolution 2560×1600 (WQXGA) Array
 - > 4 Million Micromirrors
 - 7.56-µm Micromirror Pitch
 - 0.9-Inch Micromirror Array Diagonal
 - ±12° Micromirror Tilt Angle (Relative to Flat State)
 - **Designed for Corner Illumination**
 - Integrated Micromirror Driver Circuitry
 - Two High Speed Options
- DLP9000X With a Single DLPC910 Digital Controller
 - 480 MHz Input Data Clock Rate
 - Up to 61 Giga-Bits Per Second (with Continuous Streaming Input Data)
 - Up to 14989 Hz (1-Bit Binary Patterns)
 - Up to 1873 Hz (8-Bit Gray Patterns With Illumination Modulation)
 - DLP9000 with Dual DLPC900 Digital Controllers
 - 400 MHz Input Data Clock Rate _
 - Up to 38 Giga-Bits per Second (With Up to 400 Pre-Stored Binary Patterns)
 - Up to 9523 Hz (1-Bit Binary Patterns)
 - Up to 1031 Hz (8-Bit Gray Patterns Pre-Loaded With Illumination Modulation), External Input Up to 360 Hz
- Designed for Use With Broad Wavelength Range
 - 400 nm to 700 nm
 - Window Transmission 95% (Single Pass, Through Two Window Surfaces)
 - Micromirror Reflectivity 88%
 - Array Diffraction Efficiency 86%
 - Array Fill Factor 92%



Applications 2

- Industrial
 - Machine Vision and Quality Control
 - **3D** Printing
 - **Direct Imaging Lithography**
 - Laser Marking and Repair
- Medical
 - _ Ophthalmology
 - 3D Scanners for Limb and Skin Measurement _
 - Hyper-Spectral Imaging
 - Hyper-Spectral Scanning
- Displays
 - **3D Imaging Microscopes**
 - Intelligent and Adaptive Lighting

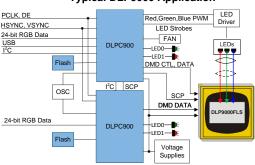
3 Description

Featuring over 4 million micromirrors, the high DLP9000 resolution and DLP9000X digital micromirror devices (DMDs) are spatial light modulators (SLMs) that modulate the amplitude, direction, and/or phase of incoming light. This advanced light control technology has numerous applications in the industrial, medical, and consumer markets. The streaming nature of the DLP9000X and its DLPC910 controller enable very high speed streaming lithographic continuous data for applications. Both DMDs enable large build sizes and fine resolution for 3D printing applications. The high resolution provides the direct benefit of scanning larger objects for 3D machine vision applications.

| Device | Information | (1) |
|--------|-------------|-----|
|--------|-------------|-----|

| PART NUMBER | PACKAGE | BODY SIZE (NOM) |
|-------------|------------|-----------------------|
| DLP9000 | | 42.20 mm x 42.20 mm x |
| DLP9000X | CLGA (355) | 7.00 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.



Typical DLP9000 Application

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (October 2015) to Revision B

Separated TCASE into TARRAY and TWINDOW. Changed TGRADIENT to TDELTA. Reduce DCLK_A,B,C,D for DLP9000 in *Absolute Maximum Ratings*. Separated Tstg into Tdmd and RH in *Storage Conditions*. Changed TDMD to TARRAY and TGRADIENT to TDELTA, added short term operational, and updated temperature values in *Recommended Operating Conditions*. Added the four modes of operation. Removed the column showing the pixel data rate and added the pattern mode pattern rates. Updated CL2w constant in *Micromirror Array Temperature Calculation*. Added recommended idle mode operation for maximizing mirror useful life. Updated Micromirror Derating Curve. Added mirror park sequence requirements. Updated device nomenclature and markings.

Changes from Original (September 2014) to Revision A

Submit Documentation Feedback

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Page

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Page

| • | Updated title | 1 |
|---|--|---|
| • | Updated Features, Description, and Device Information to include DLP9000XFLS DMD | 1 |
| • | Added DLP9000XFLS application diagram. | 1 |
| _ | | _ |



| • | Updated Absolute Maximum Ratings to include DLP9000XFLS absolute maximum ratings | 11 |
|---|---|------|
| • | Updated Recommended Operating Conditions to include DLP9000XFLS recommended operating conditions | . 12 |
| • | Updated Electrical Characteristics to include DLP9000XFLS electrical characteristics | 14 |
| • | Updated Electrical Characteristics to include DLP9000XFLS electrical characteristics | 15 |
| • | Updated Timing Requirements to include DLP9000XFLS timing requirements | 16 |
| • | Updated <i>Typical Characteristics</i> tables to have pixel data rates and pattern rates for both the DLP9000FLS and the DLP9000XFLS. | 21 |
| • | Updated Device Functional Modes section to include DLP9000X functional description. | 32 |
| • | Updated Application and Implementations section to include typical application for the DLP9000XFLS. | 37 |



DLP9000

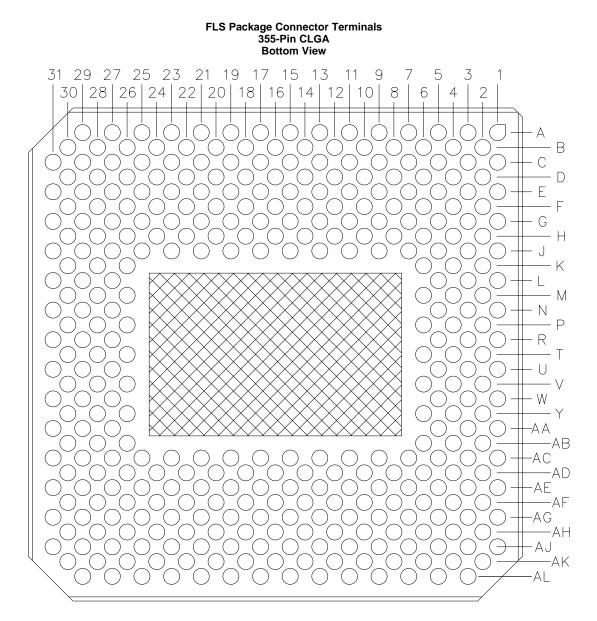
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5 Description (continued)

Reliable function and operation of the DLP9000 family requires that each DMD be used in conjunction with its specific digital controller. The DLP9000X must be driven by a single DLPC910 Controller and the DLP9000 must be driven by two DLPC900 Controllers. These dedicated chipsets provide robust, high resolution, high speed system solutions.

6 Pin Configuration and Functions



| Pin Functions | | | | | | | | | |
|---------------|-----|---------|--------|---------------------|---------------------|----------------|-----------------------|--|--|
| PIN | (1) | TYPE | CIONAL | DATA | INTERNAL | RECORDETION | TRACE | | |
| NAME | NO. | (I/O/P) | SIGNAL | RATE ⁽²⁾ | TERM ⁽³⁾ | DESCRIPTION | (mils) ⁽⁴⁾ | | |
| DATA BUS A | | | * | • | | | · | | |
| D_AN(0) | H10 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_AN(1) | G3 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_AN(2) | G9 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_AN(3) | F4 | Input | LVDS | DDR | Differential | Data, Negative | 738 | | |
| D_AN(4) | F10 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | |
| D_AN(5) | E3 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | |
| D_AN(6) | E9 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_AN(7) | D2 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_AN(8) | J5 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | |
| D_AN(9) | C9 | Input | LVDS | DDR | Differential | Data, Negative | 736 | | |
| D_AN(10) | F14 | Input | LVDS | DDR | Differential | Data, Negative | 743 | | |
| D_AN(11) | B8 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_AN(12) | G15 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | |
| D_AN(13) | B14 | Input | LVDS | DDR | Differential | Data, Negative | 740 | | |
| D_AN(14) | H16 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_AN(15) | D16 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_AP(0) | H8 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | |
| D_AP(1) | G5 | Input | LVDS | DDR | Differential | Data, Positive | 738 | | |
| D_AP(2) | G11 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | |
| D_AP(3) | F2 | Input | LVDS | DDR | Differential | Data, Positive | 736 | | |
| D_AP(4) | F8 | Input | LVDS | DDR | Differential | Data, Positive | 739 | | |
| D_AP(5) | E5 | Input | LVDS | DDR | Differential | Data, Positive | 738 | | |
| D_AP(6) | E11 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | |
| D_AP(7) | D4 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | |
| D_AP(8) | J3 | Input | LVDS | DDR | Differential | Data, Positive | 739 | | |
| D_AP(9) | C11 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | |
| D_AP(10) | F16 | Input | LVDS | DDR | Differential | Data, Positive | 741 | | |
| D_AP(11) | B10 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | |
| D_AP(12) | H14 | Input | LVDS | DDR | Differential | Data, Positive | 739 | | |
| D_AP(13) | B16 | Input | LVDS | DDR | Differential | Data, Positive | 739 | | |
| D_AP(14) | G17 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | |
| D_AP(15) | D14 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | |
| DATA BUS B | 1 | | 1 | 1 | 1 | 1 | | | |
| D_BN(0) | AD8 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | |
| D_BN(1) | AE3 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_BN(2) | AF8 | Input | LVDS | DDR | Differential | Data, Negative | 736 | | |
| D_BN(3) | AF2 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | |
| D_BN(4) | AG5 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_BN(5) | AH8 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_BN(6) | AG9 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | |
| D_BN(7) | AH2 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | |

(1) The following power supplies are required to operate the DMD: VCC, VCCI, VOFFSET, VBIAS, and VRESET. VSS must also be connected.

(2) DDR = Double Data Rate.
 SDR = Single Data Rate.
 Refer to the *Timing Requirements* regarding specifications and relationships.
 (2) Interplation of the Provide Rate Provid

(3) Internal term = CMOS level internal termination. Refer to *Recommended Operating Conditions* regarding differential termination specification.

 Delectric Constant for the DMD Type A ceramic package is approximately 9.6. For the package trace lengths shown: Propagation Speed = 11.8 / sqrt(9.6) = 3.808 in/ns. Propagation Delay = 0.262 ns/in = 262 ps/in = 10.315 ps/mm.

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NSTRUMENTS

EXAS

Pin Functions (continued)

| PIN | (1) | TYPE | | DATA | INTERNAL | | TRACE |
|--------------|------|---------|--------|---------------------|---------------------|----------------|-----------------------|
| NAME | NO. | (I/O/P) | SIGNAL | RATE ⁽²⁾ | TERM ⁽³⁾ | DESCRIPTION | (mils) ⁽⁴⁾ |
| D_BN(8) | AL9 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_BN(9) | AJ11 | Input | LVDS | DDR | Differential | Data, Negative | 738 |
| D_BN(10) | AF14 | Input | LVDS | DDR | Differential | Data, Negative | 736 |
| D_BN(11) | AE11 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_BN(12) | AH16 | Input | LVDS | DDR | Differential | Data, Negative | 740 |
| D_BN(13) | AD14 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_BN(14) | AG17 | Input | LVDS | DDR | Differential | Data, Negative | 738 |
| D_BN(15) | AD16 | Input | LVDS | DDR | Differential | Data, Negative | 738 |
| D_BP(0) | AD10 | Input | LVDS | DDR | Differential | Data, Positive | 738 |
| D_BP(1) | AE5 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_BP(2) | AF10 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_BP(3) | AF4 | Input | LVDS | DDR | Differential | Data, Positive | 738 |
| D_BP(4) | AG3 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_BP(5) | AH10 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_BP(6) | AG11 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_BP(7) | AH4 | Input | LVDS | DDR | Differential | Data, Positive | 740 |
| D_BP(8) | AL11 | Input | LVDS | DDR | Differential | Data, Positive | 736 |
| D_BP(9) | AJ9 | Input | LVDS | DDR | Differential | Data, Positive | 739 |
| D_BP(10) | AF16 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_BP(11) | AE9 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_BP(12) | AH14 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_BP(13) | AE15 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_BP(14) | AG15 | Input | LVDS | DDR | Differential | Data, Positive | 740 |
| D_BP(15) | AE17 | Input | LVDS | DDR | Differential | Data, Positive | 739 |
| DATA BUS C | I | | | 1 | | | |
| D_CN(0) | C15 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(1) | E15 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(2) | A17 | Input | LVDS | DDR | Differential | Data, Negative | 736 |
| D_CN(3) | F20 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(4) | B20 | Input | LVDS | DDR | Differential | Data, Negative | 738 |
| D_CN(5) | G21 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(6) | D22 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(7) | E23 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(8) | B26 | Input | LVDS | DDR | Differential | Data, Negative | 739 |
| D_CN(9) | F28 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(10) | C27 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(11) | J29 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(12) | D26 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CN(13) | H26 | Input | LVDS | DDR | Differential | Data, Negative | 739 |
| D_CN(14) | E29 | Input | LVDS | DDR | Differential | Data, Negative | 736 |
| D_CN(15) | G29 | Input | LVDS | DDR | Differential | Data, Negative | 737 |
| D_CP(0) | C17 | Input | LVDS | DDR | Differential | Data, Positive | 738 |
| D_CP(1) | E17 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_CP(2) | A15 | Input | LVDS | DDR | Differential | Data, Positive | 735 |
| D_CP(3) | F22 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_CP(4) | B22 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_CP(5) | H20 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_CP(6) | D20 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_CP(7) | E21 | Input | LVDS | DDR | Differential | Data, Positive | 737 |
| D_CP(8) | B28 | Input | LVDS | DDR | Differential | Data, Positive | 739 |

Pin Functions (continued)

| Pin Functions (continued) | | | | | | | | | | |
|---------------------------|-------------------|-----------------|--------|-----------------------------|---------------------------------|--------------------------|--------------------------------|--|--|--|
| PIN ⁽¹ | 1 | TYPE (I/O/P) | SIGNAL | DATA RATE ⁽²⁾ | INTERNAL TERM ⁽³⁾ | DESCRIPTION | TRACE (mils) ⁽⁴⁾ | | | |
| D_CP(9) | NO. F26 | | LVDS | DDR | | Data Desitivo | | | | |
| , | | Input | | | Differential | Data, Positive | 735 | | | |
| D_CP(10) | C29 | Input | LVDS | DDR DDR | Differential | Data, Positive | 737 737 | | | |
| D_CP(11) | J27 | Input | LVDS | | Differential | Data, Positive | | | | |
| D_CP(12) | D28 | Input | LVDS | DDR | Differential | Data, Positive | 736 | | | |
| D_CP(13) | H28 | Input | LVDS | DDR | Differential | Data, Positive | 739 | | | |
| D_CP(14) | E27 | Input | LVDS | DDR | Differential | Data, Positive | 736 | | | |
| D_CP(15) | G27 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | | |
| DATA BUS D | | | | | D / f | | | | | |
| D_DN(0) | AJ15 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | | |
| D_DN(1) | AC27 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | | |
| D_DN(2) | AK16 | Input | LVDS | DDR | Differential | Data, Negative | 738 | | | |
| D_DN(3) | AE29 | Input | LVDS | DDR | Differential | Data, Negative | 738 | | | |
| D_DN(4) | AE21 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | | |
| D_DN(5) | AF20 | Input | LVDS | DDR | Differential | Data, Negative | 738 | | | |
| D_DN(6) | AL15 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | | |
| D_DN(7) | AG29 | Input | LVDS | DDR | Differential | Data, Negative | 738 | | | |
| D_DN(8) | AD22 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | | |
| D_DN(9) | AG21 | Input | LVDS | DDR | Differential | Data, Negative | 738 | | | |
| D_DN(10) | AJ23 | Input | LVDS | DDR | Differential | Data, Negative | 736 | | | |
| D_DN(11) | AJ29 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | | |
| D_DN(12) | AF28 | Input | LVDS | DDR | Differential | Data, Negative | 737 | | | |
| D_DN(13) | AK22 | Input | LVDS | DDR | Differential | Data, Negative | 741 | | | |
| D_DN(14) | AD28 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | | |
| D_DN(15) | AK28 | Input | LVDS | DDR | Differential | Data, Negative | 739 | | | |
| D_DP(0) | AJ17 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | | |
| D_DP(1) | AC29 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | | |
| D_DP(2) | AK14 | Input | LVDS | DDR | Differential | Data, Positive | 738 | | | |
| D_DP(3) | AE27 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | | |
| D_DP(4) | AD20 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | | |
| D_DP(5) | AF22 | Input | LVDS | DDR | Differential | Data, Positive | 738 | | | |
| D_DP(6) | AL17 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | | |
| D_DP(7) | AG27 | Input | LVDS | DDR | Differential | Data, Positive | 738 | | | |
| D_DP(8) | AE23 | Input | LVDS | DDR | Differential | Data, Positive | 739 | | | |
| D_DP(9) | AG23 | Input | LVDS | DDR | Differential | Data, Positive | 738 | | | |
| D_DP(10) | AJ21 | Input | LVDS | DDR | Differential | Data, Positive | 736 | | | |
| D_DP(11) | AJ27 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | | |
| D_DP(12) | AF26 | Input | LVDS | DDR | Differential | Data, Positive | 737 | | | |
| D_DP(13) | AK20 | Input | LVDS | DDR | Differential | Data, Positive | 740 | | | |
| D_DP(14) | AD26 | Input | LVDS | DDR | Differential | Data, Positive | 739 | | | |
| D_DP(15) | AK26 | Input | LVDS | DDR | Differential | Data, Positive | 739 | | | |
| SERIAL CONTROL | | I | I | 1 | I | | I | | | |
| SCTRL_AN | D8 | Input | LVDS | DDR | Differential | Serial Control, Negative | 736 | | | |
| SCTRL_BN | AK8 | Input | LVDS | DDR | Differential | Serial Control, Negative | 739 | | | |
| SCTRL_CN | G23 | Input | LVDS | DDR | Differential | Serial Control, Negative | 737 | | | |
| SCTRL_DN | AH28 | Input | LVDS | DDR | Differential | Serial Control, Negative | 739 | | | |
| SCTRL_AP | D10 | Input | LVDS | DDR | Differential | Serial Control, Positive | 736 | | | |
| SCTRL_BP | AK10 | Input | LVDS | DDR | Differential | Serial Control, Positive | 739 | | | |
| SCTRL_CP | H22 | Input | LVDS | DDR | Differential | Serial Control, Positive | 739 | | | |
| SCTRL_DP | AH26 | Input | LVDS | DDR | Differential | Serial Control, Positive | 739 | | | |
| | /11/20 | input | 2,00 | DUN | Enterential | | 103 | | | |

EXAS NSTRUMENTS

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NSTRUMENTS

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Pin Functions (continued)

| PIN ⁽¹⁾ |) | TYPE | | DATA | INTERNAL | | TRACE |
|--------------------|-------------|---------|----------|---------------------|---------------------|---|-----------------------|
| NAME | NO. | (I/O/P) | SIGNAL | RATE ⁽²⁾ | TERM ⁽³⁾ | DESCRIPTION | (mils) ⁽⁴⁾ |
| CLOCKS | | | | | | | |
| DCLK_AN | H2 | Input | LVDS | | Differential | Clock, Negative | 740 |
| DCLK_BN | AJ5 | Input | LVDS | | Differential | Clock, Negative | 740 |
| DCLK_CN | C23 | Input | LVDS | | Differential | Clock, Negative | 736 |
| DCLK_DN | AH22 | Input | LVDS | | Differential | Clock, Negative | 736 |
| DCLK_AP | H4 | Input | LVDS | | Differential | Clock, Positive | 740 |
| DCLK_BP | AJ3 | Input | LVDS | | Differential | Clock, Positive | 740 |
| DCLK_CP | C21 | Input | LVDS | | Differential | Clock, Positive | 736 |
| DCLK_DP | AH20 | Input | LVDS | | Differential | Clock, Positive | 738 |
| SERIAL COMMUNIC | ATIONS PORT | r (SCP) | | | | | |
| SCP_DO | AC3 | Output | LVCMOS | SDR | | Serial Communications Port Output | |
| SCP_DI | AD2 | Input | LVCMOS | SDR | Pull-Down | Serial Communications Port Data Input | |
| SCP_CLK | AE1 | Input | LVCMOS | | Pull-Down | Serial Communications Port Clock | |
| SCP_ENZ | AD4 | Input | LVCMOS | | Pull-Down | Active-low Serial Communications Port | |
| MICROMIRROR RES | SET CONTROL | | | | | Enable | |
| RESET_ADDR(0) | H12 | Input | LVCMOS | | Pull-Down | Reset Driver Address Select | |
| RESET_ADDR(1) | C5 | Input | LVCMOS | | Pull-Down | Reset Driver Address Select | |
| RESET_ADDR(2) | B6 | Input | LVCMOS | | Pull-Down | Reset Driver Address Select | |
| RESET_ADDR(3) | A19 | Input | LVCMOS | | Pull-Down | Reset Driver Address Select | |
| RESET_MODE(0) | J1 | Input | LVCMOS | | Pull-Down | Reset Driver Mode Select | |
| RESET_MODE(1) | G1 | Input | LVCMOS | | Pull-Down | Reset Driver Mode Select | |
| RESET_SEL(0) | AK4 | Input | LVCMOS | | Pull-Down | Reset Driver Level Select | |
| RESET_SEL(0) | AL13 | Input | LVCMOS | | Pull-Down | Reset Driver Level Select | |
| RESET_STROBE | H6 | Input | LVCMOS | | Pull-Down | Reset Address, Mode, & Level latched on | |
| RESET_STROBE | 110 | input | LVCIVIOS | | F ull-DOWN | rising-edge | |
| ENABLES AND INT | ERRUPTS | | I | | 1 | | |
| PWRDNZ | B4 | Input | LVCMOS | | | Active-low Device Reset | |
| RESET_OEZ | AK24 | Input | LVCMOS | | Pull-Down | Active-low output enable for DMD reset driver circuits | |
| RESETZ | AL19 | Input | LVCMOS | | Pull-Down | Active-low sets Reset circuits in known VOFFSET state | |
| RESET_IRQZ | C3 | Output | LVCMOS | | | Active-low, output interrupt to ASIC | |
| VOLTAGE REGULA | | | 1 | | | | |
| PG_BIAS | J19 | Input | LVCMOS | | Pull-Up | Active-low fault from external VBIAS regulator | |
| PG_OFFSET | A13 | Input | LVCMOS | | Pull-Up | Active-low fault from external VOFFSET regulator | |
| PG_RESET | AC19 | Input | LVCMOS | | Pull-Up | Active-low fault from external VRESET regulator | |
| EN_BIAS | J15 | Output | LVCMOS | | | Active-high enable for external VBIAS regulator | |
| EN_OFFSET | H30 | Output | LVCMOS | | | Active-high enable for external VOFFSET regulator | |
| EN_RESET | J17 | Output | LVCMOS | | | Active-high enable for external VRESET regulator | |
| LEAVE PIN UNCON | NECTED | | 1 | Γ | 1 | 1 | I |
| MBRST(0) | L5 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(1) | M28 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(2) | P4 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(3) | P30 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(4) | L3 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(5) | P28 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(6) | P2 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |

8 Submit Documentation Feedback

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| DLP9000 |
|--|
| DLPS036B-SEPTEMBER 2014-REVISED OCTOBER 2016 |

Pin Functions (continued)

| PN ® TYPE SIGNAL DATA PATE (P) TRERNAL TERM (P) DESCRIPTION TRACE (mile) (P) MBRST(0) T28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(0) T44 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(10) T44 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(10) T42 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(10) L29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(13) L27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V44 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(18) V44 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(14) V42 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20)< | | | | ГШТ | unctions | (continue | u) | |
|---|-----------------|--------|--------|--------|----------|-----------|--|---------|
| Marker Table Output Analog Pull-Down For proper DMD operation, do not connect MBRST(0) Table Output Analog Pull-Down For proper DMD operation, do not connect MBRST(1) L29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(1) N29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(1) N29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(1) N29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(1) V28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(1) V28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(1) R42 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(2) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(2) W27 </th <th></th> <th>1</th> <th>-</th> <th>SIGNAL</th> <th></th> <th></th> <th>DESCRIPTION</th> <th></th> | | 1 | - | SIGNAL | | | DESCRIPTION | |
| MBRST(8) M4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(9) L29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(1) N29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(12) N3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(14) R3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(17) R29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(10) V42 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) V27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(22) V43 | | | | Apolog | | | For proper DMD operation, do not connect | (11113) |
| MBRST(9) L29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(10) T4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(12) N3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(13) L27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(15) V28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(19) A427 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(2) W37 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(2) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(2) W33 | | | | | | | | |
| MBRST(10) T4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(11) N29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(13) L27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(13) L27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(14) R3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(17) R29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(13) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(22) A3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(24) U | . , | | | | | | | |
| MBRST(1) N29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(12) N3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(14) R3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(15) V28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(17) R29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(18) Y4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(22) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W29 | | | | | | | | |
| MBRST(12) N3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(13) L27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(14) R3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(17) R29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(18) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(19) AA27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(23) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) V29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) <td< td=""><td>. ,</td><td></td><td></td><td></td><td></td><td></td><td></td><td></td></td<> | . , | | | | | | | |
| MBRST(13) L27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(14) R3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(18) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(19) A22 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(25) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) | | | | | | | | |
| MBRST(14) R3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(16) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(17) R29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(19) AA27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(22) AA3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(24) U5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(25) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(27) AA29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not con | | | | | | | | |
| MBRST(15) V28 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(15) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(17) R29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(19) A427 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(22) AA3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(24) U5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(25) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(27) AA29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) Y30 Output Analog Pull-Down For proper DMD operation, do not co | | | | | | | | |
| MBRST(16) V4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(17) R29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(18) Y4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(23) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(24) U5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(25) V29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) V2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(27) AA29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, | | | | | | | | |
| MBRST(17) R29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(18) Y4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(19) AA27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(22) AA3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(24) U5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) V2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) Y30 Output Analog Pull-Down For proper DMD operation, | | | | | | | | |
| MBRST(19) Y4 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(19) AA27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(22) AA3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(23) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) 129 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(31) R27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation | | | | | | | | |
| MBRST(19) AA27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(22) AA3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(23) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(24) U5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) V2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) V3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) V3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) Y3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) Y3 Output Analog Pull-Down For proper DMD operation, do not connect | | | | | | | | |
| MBRST(20) W3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(21) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(22) AA3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(23) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(25) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) V2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(27) AA29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) Y30 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(31) R27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(31) R27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(31) R27 Output Analog Pull-Down For proper DMD operation, do not con | . , | | | | | | | |
| MBRST(2) W27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(2) AA3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(2) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(2) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) Y2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(27) AA29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(31) R27 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(24) V30 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect RESERVED_TPK J11 Input LVCMOS Pull-Down For proper DMD operation, do not con | | | | | | | | |
| MBRST(22) AA3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(23) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(24) U5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) V2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(31) R27 Output Analog Pull-Down For proper DMD operation, do not connect RESERVED_PFE J11 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_X10 AC25 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_X12 J23 Input LVCMOS Pull-Down For proper DMD ope | . , | | Output | Analog | | | | |
| MBRST(23) W29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(24) U5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(25) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) Y2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect LEXVE PIN UNCONNECTED RESERVED_PFE J11 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_X10 AC25 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_TP0 AC3 Input LVCMOS Pull-Do | | W27 | Output | Analog | | | | |
| MBRST(24) U5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) Y2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) Y30 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(20) AA5 Output Analog Pull-Down For proper DMD operation, do not connect RESERVED_PFE J11 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_TM AC25 Input LVCMOS Pull-Down For proper DMD operatio | . , | AA3 | Output | Analog | | | For proper DMD operation, do not connect | |
| MBRST(25) U29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(26) Y2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(27) AA29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) V30 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(31) R27 Output Analog Pull-Down For proper DMD operation, do not connect RESERVED_PFE J11 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_X10 AC25 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_X11 AC23 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_X11 AC23 Input LVCMOS Pull-Down For proper D | MBRST(23) | W29 | Output | Analog | | | For proper DMD operation, do not connect | |
| MBRST(26) Y2 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(27) AA29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) Y30 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(31) R27 Output Analog Pull-Down For proper DMD operation, do not connect LEXYE PIN UNCONNECTED RESERVED_PFE J11 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_TM AC7 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_X10 AC25 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_TP0 AC9 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_TP1 AC11 Input Analog | MBRST(24) | U5 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(27) AA29 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(28) U3 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(29) Y30 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(30) AA5 Output Analog Pull-Down For proper DMD operation, do not connect MBRST(31) R27 Output Analog Pull-Down For proper DMD operation, do not connect LEAVE PIN UNCONNECTED RESERVED_PFE J11 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_TM AC7 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_TM AC25 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_X11 AC23 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_TP0 AC3 Input LVCMOS Pull-Down For proper DMD operation, do not connect RESERVED_TP1 AC11 Input Analog < | MBRST(25) | U29 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(28)U3OutputAnalogPull-DownFor proper DMD operation, do not connectMBRST(29)Y30OutputAnalogPull-DownFor proper DMD operation, do not connectMBRST(30)AA5OutputAnalogPull-DownFor proper DMD operation, do not connectMBRST(31)R27OutputAnalogPull-DownFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDNon to connectRESERVED_FFEJ11InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_X10AC25InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_X11AC23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_X12J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputAnalogFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_BAAC15OutputAnalogFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRE | MBRST(26) | Y2 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(29)Y30OutputAnalogPull-DownFor proper DMD operation, do not connectMBRST(30)AA5OutputAnalogPull-DownFor proper DMD operation, do not connectMBRST(31)R27OutputAnalogPull-DownFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDRESERVED_PFEJ11InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TMAC7InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_X10AC25InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_X12J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputL | MBRST(27) | AA29 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(30)AA5OutputAnalogPull-DownFor proper DMD operation, do not connectMBRST(31)R27OutputAnalogPull-DownFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDRESERVED_PFEJ11InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TMAC7InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI0AC25InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI1AC23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI2J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputAnalogFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC17OutputLVCMOS <td< td=""><td>MBRST(28)</td><td>U3</td><td>Output</td><td>Analog</td><td></td><td>Pull-Down</td><td>For proper DMD operation, do not connect</td><td></td></td<> | MBRST(28) | U3 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| MBRST(31)R27OutputAnalogPull-DownFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDRESERVED_PFEJ11InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TMAC7InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI0AC25InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI1AC23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI2J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputAnalogFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ21OutputLVCMOSFor proper DMD oper | MBRST(29) | Y30 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| Leave Pin UNCONNECTEDRESERVED_PFEJ11InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TMAC7InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI0AC25InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI1AC23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI2J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputAnalogFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD oper | MBRST(30) | AA5 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| RESERVED_PFEJ11InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TMAC7InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI0AC25InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI1AC23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI2J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connect< | MBRST(31) | R27 | Output | Analog | | Pull-Down | For proper DMD operation, do not connect | |
| RESERVED_TMAC7InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_X10AC25InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_X11AC23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_X12J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TS | LEAVE PIN UNCON | NECTED | | | | | | |
| RESERVED_XI0AC25InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI1AC23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI2J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputAnalogFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSJ21OutputLVCMOSFor proper DMD operation, do not connectREVED_TSAC17OutputL | RESERVED_PFE | J11 | Input | LVCMOS | | Pull-Down | For proper DMD operation, do not connect | |
| RESERVED_XI1AC23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_XI2J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputAnalogFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOS <td< td=""><td>RESERVED_TM</td><td>AC7</td><td>Input</td><td>LVCMOS</td><td></td><td>Pull-Down</td><td>For proper DMD operation, do not connect</td><td></td></td<> | RESERVED_TM | AC7 | Input | LVCMOS | | Pull-Down | For proper DMD operation, do not connect | |
| RESERVED_XI2J23InputLVCMOSPull-DownFor proper DMD operation, do not connectRESERVED_TP0AC9InputAnalogFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDUNCONNECTJ7For proper DMD operation, do not connectNO CONNECTJ9LModelFor proper DMD operation, do not connect | RESERVED_XI0 | AC25 | Input | LVCMOS | | Pull-Down | For proper DMD operation, do not connect | |
| RESERVED_TP0AC9InputAnalogFor proper DMD operation, do not connectRESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectNO CONNECTJ7ImputFor proper DMD operation, do not connectNO CONNECTJ9ImputFor proper DMD operation, do not connect | RESERVED_XI1 | AC23 | Input | LVCMOS | | Pull-Down | For proper DMD operation, do not connect | |
| RESERVED_TP1AC11InputAnalogFor proper DMD operation, do not connectRESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSJ7OutputLVCMOSFor proper DMD operation, do not connectNO CONNECTJ9Image: Second sec | RESERVED_XI2 | J23 | Input | LVCMOS | | Pull-Down | For proper DMD operation, do not connect | |
| RESERVED_TP2AC13InputAnalogFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectNO CONNECTJ7ImputImputFor proper DMD operation, do not connectNO CONNECTJ9ImputImputFor proper DMD operation, do not connect | RESERVED_TP0 | AC9 | Input | Analog | | | For proper DMD operation, do not connect | |
| LEAVE PIN UNCONNECTEDRESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDNO CONNECTJ7Image: Second | RESERVED_TP1 | AC11 | Input | Analog | | | For proper DMD operation, do not connect | |
| RESERVED_BAAC15OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BBJ13OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BCAC21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_BDJ21OutputLVCMOSFor proper DMD operation, do not connectRESERVED_TSAC17OutputLVCMOSFor proper DMD operation, do not connectLEAVE PIN UNCONNECTEDVCMOSFor proper DMD operation, do not connectNO CONNECTJ7Image: Second | RESERVED_TP2 | AC13 | Input | Analog | | | For proper DMD operation, do not connect | |
| RESERVED_BB J13 Output LVCMOS For proper DMD operation, do not connect RESERVED_BC AC21 Output LVCMOS For proper DMD operation, do not connect RESERVED_BD J21 Output LVCMOS For proper DMD operation, do not connect RESERVED_BD J21 Output LVCMOS For proper DMD operation, do not connect RESERVED_TS AC17 Output LVCMOS For proper DMD operation, do not connect LEAVE PIN UNCONNECTED NO CONNECT J7 For proper DMD operation, do not connect NO CONNECT J9 Image: Connect of the second | LEAVE PIN UNCON | NECTED | | | | | | |
| RESERVED_BC AC21 Output LVCMOS For proper DMD operation, do not connect RESERVED_BD J21 Output LVCMOS For proper DMD operation, do not connect RESERVED_TS AC17 Output LVCMOS For proper DMD operation, do not connect RESERVED_TS AC17 Output LVCMOS For proper DMD operation, do not connect LEAVE PIN UNCONNECTED VO CONNECT J7 Image: Connect of the second sec | RESERVED_BA | AC15 | Output | LVCMOS | | | For proper DMD operation, do not connect | |
| RESERVED_BD J21 Output LVCMOS For proper DMD operation, do not connect RESERVED_TS AC17 Output LVCMOS For proper DMD operation, do not connect LEAVE PIN UNCONNECTED NO CONNECT J7 Image: Connect of the second connect of t | RESERVED_BB | J13 | Output | LVCMOS | | | For proper DMD operation, do not connect | |
| RESERVED_TS AC17 Output LVCMOS For proper DMD operation, do not connect LEAVE PIN UNCONNECTED J7 J7 For proper DMD operation, do not connect NO CONNECT J9 Image: Connect of the second seco | RESERVED_BC | AC21 | Output | LVCMOS | | | For proper DMD operation, do not connect | |
| LEAVE PIN UNCONNECTED NO CONNECT J7 General and a strength of the str | RESERVED_BD | J21 | Output | LVCMOS | | | For proper DMD operation, do not connect | |
| NO CONNECT J7 For proper DMD operation, do not connect NO CONNECT J9 For proper DMD operation, do not connect | RESERVED_TS | AC17 | Output | LVCMOS | | | For proper DMD operation, do not connect | |
| NO CONNECT J9 For proper DMD operation, do not connect | LEAVE PIN UNCON | NECTED | | | ı | | | ı |
| | NO CONNECT | J7 | | | | | For proper DMD operation, do not connect | |
| NO CONNECT J25 For proper DMD operation, do not connect | NO CONNECT | J9 | | | | | For proper DMD operation, do not connect | |
| | NO CONNECT | J25 | | | | | For proper DMD operation, do not connect | |



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STRUMENTS

ÈXAS

| Pin Functions | | | | | | | |
|---------------------|--|---------|--------|---|--|--|--|
| PIN | | TYPE | | DECODIDION | | | |
| NAME ⁽¹⁾ | NO. | (I/O/P) | SIGNAL | DESCRIPTION | | | |
| VBIAS | A3, A9, A5, A11, A7, B2 | Power | Analog | Supply voltage for positive Bias level of Micromirror reset signal. | | | |
| | L1, N1, R1 | Power | Analog | Supply voltage for HVCMOS logic. | | | |
| VOFFSET | U1, W1 | Power | Analog | Supply voltage for stepped high voltage at Micromirror address electrodes. | | | |
| | AC1, AA1 | Power | Analog | Supply voltage for Offset level of MBRST(31:0). | | | |
| VRESET | L31, N31, R31, U31, W31, AA31 | Power | Analog | Supply voltage for negative Reset level of Micromirror reset signal. | | | |
| VCC | A21, A23, A25, A27, A29, C1, C31, E31, G31, J31, K2, AC31, AE31, AG1, AG31, AJ31, AK2, AK30, AL3, AL5, AL7, AL21, AL23, AL25, AL27 | Power | Analog | Supply voltage for LVCMOS core logic. Supply voltage for normal high level at Micromirror address electrodes. | | | |
| VCCI | H18, H24, M6, M26, P6, P26, T6, T26, V6, V26, Y6, Y26, AD6, AD12, AD18, AD24 | Power | Analog | Supply voltage for LVDS receivers. | | | |
| VSS | A1, B12, B18, B24, B30, C7, C13, C19, C25, D6, D12, D18, D24, D30, E1, E7, E13, E19, E25, F6, F12, F18, F24, F30, G7, G13, G19, G25, K4, K6, K26, K28, K30, M2, M30, N5, N27, R5, T2, T30, U27, V2, V30, W5, Y28, AB2, AB4, AB6, AB26, AB28, AB30, AC5, AD30, AE7, AE13, AE19, AE25, AF6, AF12, AF18, AF24, AF30, AG7, AG13, AG19, AG25, AH6, AH12, AH18, AH24, AH30, AJ1, AJ7, AJ13, AJ19, AJ25, AK6, AK12, AK18, AL29 | Power | Analog | Device Ground. Common return for all power. | | | |

(1) The following power supplies are required to operate the DMD: VCC, VCCI, VOFFSET, VBIAS, and VRESET. VSS must also be connected.



7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

| | | | MIN | MAX | UNIT |
|---------------------|---|---|------|------------|-------|
| SUPPLY VOLTAGES | | | | | |
| VCC | Supply voltage f | Supply voltage for LVCMOS core logic ⁽²⁾ | | | V |
| VCCI | Supply voltage f | or LVDS receivers ⁽²⁾ | -0.5 | 4 | V |
| VOFFSET | Supply voltage f | or HVCMOS and micromirror electrode (2) (3) | -0.5 | 9 | V |
| VBIAS | Supply voltage f | or micromirror electrode (2) | -0.5 | 17 | V |
| VRESET | Supply voltage f | or micromirror electrode (2) | -11 | 0.5 | V |
| VCC – VCCI | Supply voltage of | delta (absolute value) ⁽⁴⁾ | | 0.3 | V |
| VBIAS – VOFFSET | Supply voltage of | delta (absolute value) ⁽⁵⁾ | | 8.75 | V |
| INPUT VOLTAGES | | | | | |
| | Input voltage for | all other LVCMOS input pins ⁽²⁾ | -0.5 | VCC + 0.3 | V |
| | Input voltage for | all other LVDS input pins ^{(2) (6)} | -0.5 | VCCI + 0.3 | V |
| V _{ID} | Input differential | Input differential voltage (absolute value) (7) | | 700 | mV |
| I _{ID} | Input differential | current ⁽⁷⁾ | | 7 | mA |
| CLOCKS | | | - | | |
| | DLP9000 | Clock frequency for LVDS interface, DCLK_A | | 440 | |
| | | Clock frequency for LVDS interface, DCLK_B | | 440 | |
| | | Clock frequency for LVDS interface, DCLK_C | | 440 | |
| £ | | Clock frequency for LVDS interface, DCLK_D | | 440 | MHz |
| $f_{ m clock}$ | DLP9000X | Clock frequency for LVDS interface, DCLK_A | | 500 | IVIEZ |
| | | Clock frequency for LVDS interface, DCLK_B | | 500 | |
| | | Clock frequency for LVDS interface, DCLK_C | | 500 | |
| | | Clock frequency for LVDS interface, DCLK_D | | 500 | |
| ENVIRONMENTAL | | | | | |
| - | Array temperatu | re: operational ^{(8) (9)} | 0 | 90 | °C |
| T _{ARRAY} | Array temperature: non-operational ⁽⁹⁾ | | -40 | 90 | ÷C |
| т | Window temperature: operational | | 0 | 70 | °C |
| T _{WINDOW} | Window tempera | ature: non-operational | -40 | 90 | -U |
| T _{DELTA} | Absolute termpe ceramic test poi | rature delta between the window test points and the nt TP1 $^{\left(10\right) }$ | | 10 | ٥C |
| RH | Relative Humidi | ty, operating and non-operating | | 95% | |

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device is not implied at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure above Recommended Operating Conditions for extended periods may affect device reliability.

(2) All voltages are referenced to common ground VSS. Supply voltages VCC, VCCI, VOFFSET, VBIAS, and VRESET are all required for proper DMD operation. VSS must also be connected.

(3) VOFFSET supply transients must fall within specified voltages.

(4) To prevent excess current, the supply voltage delta |VCCI – VCC| must be less than specified limit.

(5) To prevent excess current, the supply voltage delta |VBIAS – VOFFSET| must be less than specified limit. Refer to *Power Supply Requirements* for additional information.

(6) This maximum LVDS input voltage rating applies when each input of a differential pair is at the same voltage potential.

(7) LVDS differential inputs must not exceed the specified limit or damage may result to the internal termination resistors.

(8) Exposure of the DMD simultaneously to any combination of the maximum operating conditions for case temperature, differential temperature, or illumination power density may affect device reliability.

(9) The highest temperature of the active array as calculated by the *Micromirror Array Temperature Calculation* using ceramic test point 1 (TP1) in Figure 15.

(10) Temperature delta is the highest difference between the ceramic test point TP1 and window test points TP2 and TP3 in Figure 15.

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7.2 Storage Conditions

applicable before the DMD is installed in the final product

| | | MIN | MAX | UNIT |
|------------------|-------------------------------------|-----|-----|------|
| T _{DMD} | DMD storage temperature | -40 | 80 | °C |
| RH | Relative Humidity, (non-condensing) | | 95% | |

7.3 ESD Ratings

| | | VALUE | UNIT |
|--|--|-------|------|
| V _(ESD) Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins (1) | ±2000 | V |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

7.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | | | MIN | NOM | MAX | UNIT |
|---------------------------|--|--|-------|------|-----------|------|
| SUPPLY VO | LTAGES ⁽¹⁾ ⁽²⁾ | | I | | | |
| VCC | DLP9000 Supply voltage for LVCMOS core logic DLP9000X Supply voltage for LVCMOS core logic | | 3.0 | 3.3 | 3.6 | V |
| VCC | | | 3.3 | 3.45 | 3.6 | V |
| VOOL | DLP9000 | Supply voltage for LVDS receivers | 3.0 | 3.3 | 3.6 | N/ |
| VCCI | DLP9000X | Supply voltage for LVDS receivers | 3.3 | 3.45 | 3.6 | V |
| VOFFSET | Supply voltage for H | /CMOS and micromirror electrodes ⁽³⁾ | 8.25 | 8.5 | 8.75 | V |
| VBIAS | | | 15.5 | 16 | 16.5 | V |
| VRESET | Supply voltage for m | cromirror electrodes | -9.5 | -10 | -10.5 | V |
| VCCI-VCC | Supply voltage delta | (absolute value) (4) | | | 0.3 | V |
| VBIAS-VO FFSET | Supply voltage delta | | | 8.75 | V | |
| LVCMOS PIN | IS | | | | | |
| V _{IH} | High level Input volta | ge ⁽⁶⁾ | 1.7 | 2.5 | VCC + 0.3 | V |
| V _{IL} | Low level Input voltage | ge ⁽⁶⁾ | - 0.3 | | 0.7 | V |
| I _{OH} | High level output cur | rent at V _{OH} = 2.4 V | | | -20 | mA |
| I _{OL} | Low level output curr | ent at V _{OL} = 0.4 V | | | 15 | mA |
| T _{PWRDNZ} | PWRDNZ pulse widt | h ⁽⁷⁾ | 10 | | | ns |
| SCP INTERF | ACE | | | | | |
| f _{clock} | SCP clock frequency | (8) | | | 500 | kHz |
| t _{SCP_SKEW} | Time between valid S | SCPDI and rising edge of SCPCLK ⁽⁹⁾ | -800 | | 800 | ns |
| t _{SCP_DELAY} | Time between valid S | SCPDO and rising edge of SCPCLK ⁽⁹⁾ | | | 700 | ns |
| t _{SCP_BYTE_INT} | Time between conse | cutive bytes | 1 | | | μs |
| t _{SCP_NEG_ENZ} | Time between falling | edge of SCPENZ and the first rising edge of SCPCLK | 30 | | | ns |
| t _{SCP_PW_ENZ} | SCPENZ inactive pu | se width (high level) | 1 | | | μs |
| t _{SCP_OUT_EN} | Time required for SC | P output buffer to recover after SCPENZ (from tri-state) | | | 1.5 | ns |
| f _{clock} | SCP circuit clock osc | illator frequency (10) | 9.6 | | 11.1 | MHz |

(1) Supply voltages VCC, VCCI, VOFFSET, VBIAS, and VRESET are all required for proper DMD operation. VSS must also be connected.

All voltages are referenced to common ground VSS. (2)

VOFFSET supply transients must fall within specified max voltages. (3)

(4)

To prevent excess current, the supply voltage delta |VCCI – VCC| must be less than specified limit. To prevent excess current, the supply voltage delta |VBIAS – VOFFSET| must be less than specified limit. Refer to *Power Supply* (5) Requirements for additional information.

(6) Tester Conditions for V_{IH} and V_{IL}: Frequency = 60 MHz. Maximum Rise Time = 2.5 ns at (20% to 80%) Frequency = 60 MHz. Maximum Fall Time = 2.5 ns at (80% to 20%)

(7) PWRDNZ input pin resets the SCP and disables the LVDS receivers. PWRDNZ input pin overrides SCPENZ input pin and tri-states the SCPDO output pin.

The SCP clock is a gated clock. Duty cycle shall be 50% ± 10%. SCP parameter is related to the frequency of DCLK. (8)

(9) Refer to Figure 1.

(10) SCP internal oscillator is specified to operate all SCP registers. For all SCP operations, DCLK is required.



Recommended Operating Conditions (continued)

over operating free-air temperature range (unless otherwise noted)

| | | | MIN | NOM | MAX | UNIT | |
|------------------------|---|---|-----|-------------------------|-----------------------|-------------------|--|
| LVDS INTE | RFACE | | | | | | |
| £ | DLP9000 | Clock frequency DCLK | | 400 480 | | MHz | |
| f _{clock} | DLP9000X | Clock frequency DCLK (11) | 400 | | | IVITIZ | |
| V _{ID} | Input differential | voltage (absolute value) (12) | 100 | 400 | 600 | mV | |
| V _{CM} | Common mode (1 | 2) | | 1200 | | mV | |
| V _{LVDS} | LVDS voltage (12) | | 0 | | 2000 | mV | |
| t _{LVDS_RSTZ} | Time required for | LVDS receivers to recover from PWRDNZ | | | 10 | ns | |
| Z _{IN} | Internal differentia | al termination resistance | 95 | | 105 | Ω | |
| Z _{LINE} | Line differential in | npedance (PWB/trace) | 90 | 100 | 110 | Ω | |
| | IENTAL ⁽¹³⁾ For Illu | mination Source Between 420 nm and 700 nm | | | · | | |
| | | Array temperature, Long-term operational ⁽¹⁴⁾ (15)(16) | 10 | 40 | to 65 ⁽¹⁷⁾ | | |
| - | DLP9000 | Array temperature, Short-term operational (14) (15)(18) | 0 | | 10 | °C | |
| T _{ARRAY} | DLP9000X | Array temperature, Long-term operational ⁽¹⁴⁾ (15)(16) | 10 | | 40 (19) | Ĵ | |
| | | Array temperature, Short-term operational (14) (15)(18) | 0 | | 10 | | |
| T _{WINDOW} | DLP9000 | Window Temperature test points TP2 and TP3, Long-term operational ⁽¹⁶⁾ | 10 | | 70 | | |
| | DLP9000X | Window Temperature test points TP2 and TP3, Long-term operational ⁽¹⁶⁾ | 10 | | 40 | °C | |
| T _{delta} | Absolute Temperature delta between the window test points (TP2, TP3) and the ceramic test point TP1 ⁽²⁰⁾ | | | | 10 | °C | |
| ILL _{VIS} | Illumination | | | Thermally mited (21) | mW/cm ² | | |
| RH | Relative Humidity | (non-condensing) | | | 95% | | |
| ENVIRONN | IENTAL ⁽¹³⁾ For Illu | mination Source Between 400 nm and 420 nm | | | 1 | | |
| - | Array temperature | e, Long-term operational (14) (15)(16) | 20 | | 30 | | |
| T _{ARRAY} | Array temperature | e, Short-term operational (14) (15)(18) | 0 | | 20 | °C | |
| T _{WINDOW} | Window Tempera | ture test points TP2 and TP3, Long-term operational ⁽¹⁶⁾ | | | 30 | °C | |
| T _{delta} | Absolute Temper ceramic test point | ature delta between the window test points (TP2, TP3) and the t TP1 $^{\rm (20)}$ | | | 10 | °C | |
| ILL _{VIS} | Illumination 10 | | | | 10 | W/cm ² | |
| RH | Relative Humidity | (non-condensing) | | | 95% | | |
| | IENTAL ⁽¹³⁾ For Illu | mination Source <400 nm and >700 nm | | | | | |
| | DI Dagaa | Array temperature, Long-term operational ⁽¹⁴⁾ (15)(16) | 10 | 40 | to 65 ⁽¹⁷⁾ | | |
| - | DLP9000 | Array temperature, Short-term operational (14) (15)(18) | 0 | | 10 | | |
| T _{ARRAY} | DLP9000X | Array temperature, Long-term operational ⁽¹⁴⁾ (15)(16) | 10 | | 40 (19) | °C | |
| | | Array temperature, Short-term operational (14) (15)(18) | 0 | | 10 | 10 | |

(11) The DLP9000X, coupled with the DLPC910, is designed for operation at 2 specific DCLK frequencies only - 400 MHz or 480 MHz. 480 MHz operation is only allowed at the specific environmental operating conditions as shown in this table.

(12) Refer to Figure 2, Figure 3, and Figure 4.

(13) Optimal, long-term performance and optical efficiency of the Digital Micromirror Device (DMD) can be affected by various application parameters, including illumination spectrum, illumination power density, micromirror landed duty-cycle, ambient temperature (storage and operating), DMD temperature, ambient humidity (storage and operating), and power on or off duty cycle. TI recommends that application-specific effects be considered as early as possible in the design cycle.

(14) The array temperature cannot be measured directly and must be computed analytically from the temperature measured at test point 1 (TP1) shown in Figure 15 and the package thermal resistance in *Thermal Information* using *Micromirror Array Temperature Calculation*.

(15) Simultaneous exposure of the DMD to the maximum *Recommended Operating Conditions* for temperature and UV illumination will reduce device lifetime.

(16) Long-term is defined as the usable life of the device.

(17) Per Figure 16, the maximum operational case temperature should be derated based on the micromirror landed duty cycle that the DMD experiences in the end application. Refer to *Micromirror Landed-On/Landed-Off Duty Cycle* for a definition of micromirror landed duty cycle.

(18) Array and Window temperatures beyond those specified as long-term are recommended for short-term conditions only (power-up). Short-term is defined as cumulative time over the usable life of the device and is less than 500 hours.

(19) For the DLP9000X, Figure 16 does not apply and the maximum temperature is as specified in table.

(20) Temperature delta is the highest difference between the ceramic test point (TP1) and window test points (TP2) and (TP3) in Figure 15. (21) Refer to *Thermal Information* and *Micromirror Array Temperature Calculation*.

Recommended Operating Conditions (continued)

over operating free-air temperature range (unless otherwise noted)

| | | | MIN | NOM MAX | UNIT |
|---------------------|--|---|-----|---------|--------------------|
| T _{WINDOW} | DLP9000 | Window Temperature test points TP2 and TP3, Long-term operational ⁽¹⁶⁾ | 10 | 70 | °C |
| | DLP9000X Window Temperature test points TP2 and TP3, Long-term operational ⁽¹⁶⁾ | | 10 | 40 | -0 |
| T _{DELTA} | T _{DELTA} Absolute Temperature delta between the window test points (TP2, TP3) and the ceramic test point TP1 ⁽²⁰⁾ | | | 10 | °C |
| ILL _{UV} | L _{UV} Illumination, wavelength < 400 nm | | | 0.68 | mW/cm ² |
| ILL _{IR} | ILL _{IR} Illumination, wavelength > 700 nm | | | 10 | mW/cm ² |
| RH | Relative Humidity (no | n-condensing) | | 95% | |

7.5 Thermal Information

| | | DLP9000 | |
|----------------|---|------------|------|
| | THERMAL METRIC ⁽¹⁾ | FLS (CLGA) | UNIT |
| | | 355 PINS | |
| R_{\thetaJA} | Thermal resistance, active area to test point 1 (TP1) (max) | 0.5 | °C/W |

(1) The DMD is designed to conduct absorbed and dissipated heat to the back of the package where it can be removed by an appropriate heat sink. The heat sink and cooling system must be capable of maintaining the package within the temperature range specified in the *Recommended Operating Conditions*. The total heat load on the DMD is largely driven by the incident light absorbed by the active area, although other contributions include light energy absorbed by the window aperture and electrical power dissipation of the array. Optical systems should be designed to minimize the light energy falling outside the window clear aperture since any additional thermal load in this area can significantly degrade the reliability of the device.

7.6 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS ⁽¹⁾ | MIN | TYP | MAX | UNIT |
|--------------------|---|-------------------------------------|------|-----|------|------|
| V _{OH} | High-level output voltage | VCC = 3 V, I _{OH} = -20 mA | 2.4 | | | V |
| V _{OL} | Low level output voltage | VCC = 3.6, I _{OL} = 15 mA | | | 0.4 | V |
| I _{IH} | High-level input current ^{(2) (3)} | $VCC = 3.6 V, V_I = VCC$ | | | 250 | μA |
| IIL | Low level input current | VCC = 3.6 V, V _I = 0 | -250 | | | μA |
| I _{OZ} | High-impedance output current | VCC = 3.6 V | | | 10 | μA |
| CURRENT | | | | | | |
| | | DLP9000 VCC = 3.6 V, DCLK=400 MHz | | | 1600 | |
| I _{CC} | | DLP9000X VCC = 3.6V, DCLK=480 MHz | | | 1850 | |
| | Supply current ⁽⁴⁾ | DLP9000 VCCI = 3.6 V, DCLK=400 MHz | | | 985 | mA |
| Icci | | DLP9000X VCCI = 3.6, DCLK=480 MHz | | | 1100 | |
| IOFFSET | 2 (5) | VOFFSET = 8.75 V | | 25 | | |
| I _{BIAS} | Supply current ⁽⁵⁾ | VBIAS = 16.5 V | 14 | | mA | |
| IRESET | | VRESET = -10.5 V | | | 11 | |
| I _{TOTAL} | Supply current | DLP9000 Total Sum | | | 2634 | mA |
| | | DLP9000X Total Sum | 3000 | | | |
| POWER | | | 1 | | | |

 All voltages are referenced to common ground VSS. Supply voltages VCC, VCCI, VOFFSET, VBIAS, and VRESET are all required for proper DMD operation. VSS must also be connected.

- (2) Applies to LVCMOS input pins only. Does not apply to LVDS pins and MBRST pins.
- (3) LVCMOS input pins utilize an internal 18000 Ω passive resistor for pull-up and pull-down configurations. Refer to *Pin Configuration and Functions* to determine pull-up or pull-down configuration used.
- (4) To prevent excess current, the supply voltage delta |VCCI VCC| must be less than specified limit.
- (5) To prevent excess current, the supply voltage delta |VBIAS VOFFSET| must be less than specified limit.

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Electrical Characteristics (continued)

| over operating | free-air t | emperature ran | ne (unless | otherwise noted) |
|----------------|------------|----------------|------------|------------------|
| | nee-an i | | | |

| | PARAMETER | TEST CONDITIONS ⁽¹⁾ | MIN TYP | MAX | UNIT |
|---------------------|---|------------------------------------|---------|-------|-------|
| P | | DLP9000 VCC = 3.6 V | | 5760 | |
| P _{CC} | | DLP9000X VCC = 3.6 V | | 6660 | mW |
| D | | DLP9000 VCCI = 3.6 V | | 3546 | |
| P _{CCI} | Supply power dissipation | DLP9000X VCCI = 3.6 V | | 3960 | mW |
| P _{OFFSET} | | VOFFSET = 8.75 V | | 219 | mW |
| P _{BIAS} | | VBIAS = 16.5 V | | 231 | mW |
| P _{RESET} | | VRESET = -10.5 V | | 115 | mW |
| D | Supply power dissipation ⁽⁶⁾ | DLP9000 Total Sum, DCLK = 400 MHz | | 9871 | mW |
| P _{TOTAL} | Supply power dissipation (* | DLP9000X Total Sum, DCLK = 480 MHz | | 11185 | IIIVV |
| CAPACITANC | E | | | | |
| CI | Input capacitance | f = 1 MHz | | 10 | pF |
| Co | Output capacitance | f = 1 MHz | | 10 | pF |
| | Reset group capacitance MBRST(31:0) | f = 1 MHz; 2560 × 50 micromirrors | 230 | 290 | pF |

(6) Total power on the active micromirror array is the sum of the electrical power dissipation and the absorbed power from the illumination source. See the *Micromirror Array Temperature Calculation*.

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7.7 Timing Requirements

over Recommended Operating Conditions (unless otherwise noted) ⁽¹⁾

| | | | | MIN | NOM | MAX | UNIT | |
|-----------------|-------------------------|-----------------|--|-------|-------|-----|------|--|
| SCP INT | FERFACE ⁽²⁾ | | | | | | | |
| t _r | Rise time | 20% to 80% | | | | 200 | ns | |
| t _f | Fall time | 80% to 20% | | | | 200 | ns | |
| LVDS IN | NTERFACE ⁽²⁾ | T | | | | | | |
| t _r | Rise time | 20% to 80% | | 100 | | 400 | ps | |
| t _f | Fall time | 80% to 20% | | 100 | | 400 | ps | |
| LVDS C | LOCKS ⁽³⁾ | T | | | | | | |
| | | | DCLK_A, 50% to 50% | 2.5 | | | | |
| | | DLP9000 | DCLK_B, 50% to 50% | 2.5 | | | | |
| | | 22.0000 | DCLK_C, 50% to 50% | 2.5 | | | | |
| t _c | Cycle time | | DCLK_D, 50% to 50% | 2.5 | | | ns | |
| •c | Oycle unic | | DCLK_A, 50% to 50% | 2.083 | | | 115 | |
| | | DLP9000X | DCLK_B, 50% to 50% | 2.083 | | | | |
| | | DEI SOOOX | DCLK_C, 50% to 50% | 2.083 | | | | |
| | | | DCLK_D, 50% to 50% | 2.083 | | | | |
| | | | DCLK_A, 50% to 50% | 1.19 | 1.25 | | | |
| | | DLP9000 | DCLK_B, 50% to 50% | 1.19 | 1.25 | | | |
| | | DEL 2000 | DCLK_C, 50% to 50% | 1.19 | 1.25 | | | |
| | Pulse w duration | | DCLK_D, 50% to 50% | 1.19 | 1.25 | | 20 | |
| t _w | | | DCLK_A, 50% to 50% | 1.031 | 1.042 | | ns | |
| | | DI DOGGOV | DCLK_B, 50% to 50% | 1.031 | 1.042 | | | |
| | | DLP9000X | DCLK_C, 50% to 50% | 1.031 | 1.042 | | | |
| | | | DCLK_D, 50% to 50% | 1.031 | 1.042 | | | |
| LVDS IN | NTERFACE ⁽³⁾ | I. | | H | | | | |
| | | D_A(15:0) befor | e rising or falling edge of DCLK_A | 0.2 | | | | |
| | | D_B(15:0) befor | e rising or falling edge of DCLK_B | 0.2 | | | | |
| t _{su} | Setup time | D_C(15:0) befor | e rising or falling edge of DCLK_C | 0.2 | | | ns | |
| | | D_D(15:0) befor | e rising or falling edge of DCLK_D | 0.2 | | | | |
| | | SCTRL_A before | e rising or falling edge of DCLK_A | 0.2 | | | | |
| | | SCTRL_B before | e rising or falling edge of DCLK_B | 0.2 | | | | |
| t _{su} | Setup time | SCTRL_C befor | e rising or falling edge of DCLK_C | 0.2 | | | ns | |
| | | SCTRL_D befor | e rising or falling edge of DCLK_D | 0.2 | | | | |
| | | | D_A(15:0) after rising or falling edge of DCLK_A | 0.5 | | | | |
| | | | D_B(15:0) after rising or falling edge of DCLK_B | 0.5 | | | | |
| | | DLP9000 | D_C(15:0) after rising or falling edge of DCLK_C | 0.5 | | | | |
| | | | D_D(15:0) after rising or falling edge of DCLK_D | 0.5 | | | | |
| t _h | Hold time | | D_A(15:0) after rising or falling edge of DCLK_A | 0.4 | | | ns | |
| | | | D_B(15:0) after rising or falling edge of DCLK_B | 0.4 | | | | |
| | | DLP9000X | D_C(15:0) after rising or falling edge of DCLK_C | 0.4 | | | | |
| | | | D_D(15:0) after rising or falling edge of DCLK_D | 0.4 | | | | |
| | | | SCTRL A after rising or falling edge of DCLK A | 0.5 | | | | |
| | | | SCTRL_B after rising or falling edge of DCLK_B | 0.5 | | | | |
| | | DLP9000 | SCTRL_C after rising or falling edge of DCLK_C | 0.5 | | | | |
| | | | SCTRL_D after rising or falling edge of DCLK_D | 0.5 | | | | |
| t _h | Hold time | | SCTRL_D after rising or falling edge of DCLK_D | 0.3 | | | ns | |
| | | | SCTRL_A after rising of failing edge of DCLK_A SCTRL_B after rising or falling edge of DCLK_B | 0.4 | | | | |
| | | DLP9000X | SCTRL_B after rising of failing edge of DCLK_B SCTRL_C after rising or failing edge of DCLK_C | 0.4 | | | | |
| | | | | 04 | | | | |

Refer to *Pin Configuration and Functions* for pin details. Refer to Figure 5. Refer to Figure 6. (1)

(2) (3)

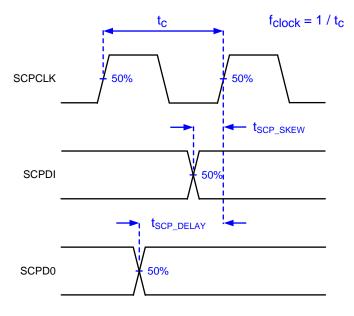
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Timing Requirements (continued)

over Recommended Operating Conditions (unless otherwise noted) (1)

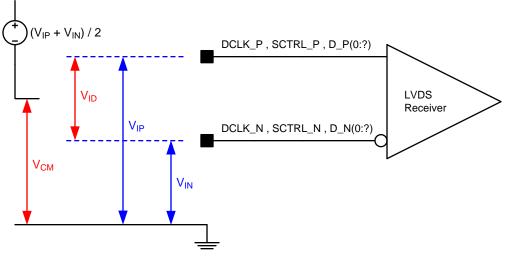
| | | | | MIN | NOM | MAX | UNIT |
|-------------------|--|---|--|-------------------------------|------|------|------|
| LVDS INTER | RFACE ⁽³⁾ | | | | | | |
| | | | DLP9000 Channel A includes the following LVDS pairs: DCLK_AP and DCLK_AN SCTRL_AP and SCTRL_AN D_AP(15:0) and D_AN(15:0) | 1.25 | | 1.25 | 25 |
| | | Channel B | DLP9000 Channel B includes the following LVDS pairs: DCLK_BP and DCLK_BN SCTRL_BP and SCTRL_BN D_BP(15:0) and D_BN(15:0) | les the following LVDS pairs: | | 1.25 | ns |
| | | Channel A DLP9000X Channel A includes the following LVDS pairs: DCLK_AP and DCLK_AN SCTRL_AP and SCTRL_AN D_AP(15:0) and D_AN(15:0) DLP9000X Channel B includes the following LVDS pairs: DCLK_BP and DCLK_BN SCTRL_BP and SCTRL_BN D BP(15:0) and D BN(15:0) | DCLK_AP and DCLK_AN SCTRL_AP and SCTRL_AN | | | | ns |
| | Skew time | | -1.04 | | 1.04 | 115 | |
| t _{skew} | DLP9000 Channel C includes the following LVDS DCLK_CP and DCLK_CN SCTRL_CP and SCTRL_CN D_CP(15:0) and D_CN(15:0) | SCTRL_CP and SCTRL_CN | | | 4.05 | | |
| | | Channel D | DLP9000 Channel D includes the following LVDS pairs: DCLK_DP and DCLK_DN SCTRL_DP and SCTRL_DN D_DP(15:0) and D_DN(15:0) | - –1.25 | 1.2 | 1.25 | ns |
| | | relative to Channel C DLP9000X Channel C includes the following LVDS pairs: DCLK_CP and DCLK_CN SCTRL_CP and SCTRL_CN D_CP(15:0) and D_CN(15:0) | | 1.04 | | | |
| | | | DLP9000X Channel D includes the following LVDS pairs: DCLK_DP and DCLK_DN SCTRL_DP and SCTRL_DN D_DP(15:0) and D_DN(15:0) | -1.04 | | 1.04 | ns |



Not to scale.

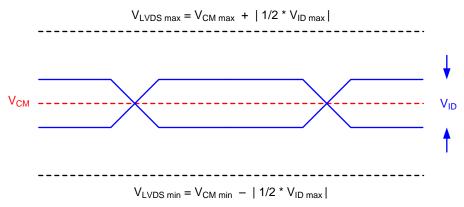
Refer to SCP Interface section of the Recommended Operating Conditions table.

Figure 1. SCP Timing Parameters



Refer to LVDS Interface section of the Recommended Operating Conditions table. Refer to Pin Configuration and Functions for list of LVDS pins.

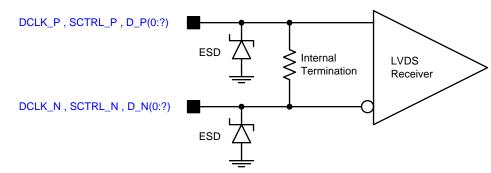




Not to scale.

Refer to LVDS Interface section of the Recommended Operating Conditions table.

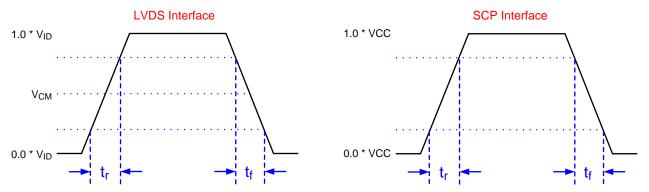
Figure 3. LVDS Voltage Parameters



Refer to LVDS Interface section of the Recommended Operating Conditions table. Refer to Pin Configuration and Functions for list of LVDS pins.

Figure 4. LVDS Equivalent Input Circuit



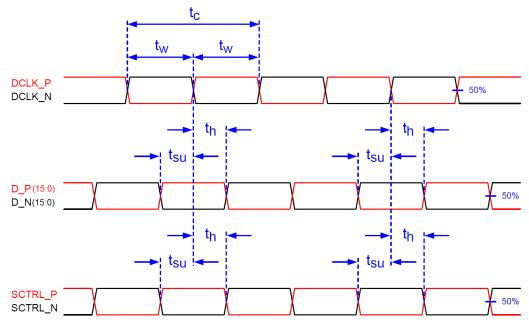


Not to scale.

Refer to the Timing Requirements table

Refer to Pin Configuration and Functions for a list of LVDS pins and SCP pins..

Figure 5. Rise Time and Fall Time

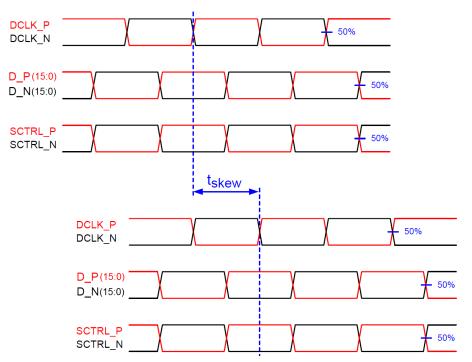


Not to scale.

Refer to LVDS INTERFACE section in the Timing Requirements table.







Not to scale.

Refer to LVDS INTERFACE section in the Timing Requirements table.

Figure 7. LVDS Interface Channel Skew Definition



7.8 Capacitance at Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | MAX | UNIT |
|-----|-------------------------------|---------------------------------------|-----|-----|------|
| CI | Input capacitance | f = 1 MHz | | 10 | pF |
| Co | Output capacitance | f = 1 MHz | | 10 | pF |
| CIM | MBRST(31:0) input capacitance | f = 1 MHz. All inputs interconnected. | 230 | 290 | pF |

7.9 Typical Characteristics

When the DLP9000 DMD is controlled by two DLPC900 controllers, these digital controllers offer four modes of operation.

- 1. Video Mode
- 2. Video Pattern Mode
- 3. Pre-Stored Pattern Mode
- 4. Pattern On-The-Fly Mode

In video mode, the video source is displayed on the DMD at the rate of the incoming video source.

In modes 2, 3, and 4, the pattern rates depend on the bit depth as shown in Table 1.

When the DLP9000X DMD is controlled by the DLPC910 controller, the digital controller offers streaming 1-bit binary patterns to the DMD at speeds greater than 61 Gigabits per second (Gbps). The patterns are streamed from a customer designed applications processor into the DLPC910 input LVDS data interface. Table 2 shows the pattern rates for the different DMD Reset Modes.

Table 1. DLPC900 with DLP9000 Pattern Rate versus Bit Depth

| BIT DEPTH | VIDEO PATTERN MODE (Hz) | PRE-STORED or PATTERN ON- THE-FLY MODE (Hz) |
|-----------|-------------------------|--|
| 1 | 2880 | 9523 |
| 2 | 1440 | 3289 |
| 3 | 960 | 2638 |
| 4 | 720 | 1364 |
| 5 | 480 | 823 |
| 6 | 480 | 672 |
| 7 | 360 | 500 |
| 8 | 247 | 247 |

Table 2. DLPC910 with DLP9000X Pattern Rates versus Reset Mode

| RESET MODE ⁽¹⁾ | MAX PIXEL DATA RATE (Gbps) ⁽²⁾ | MAX PATTERN RATE (Hz) ⁽³⁾ |
|---------------------------|---|--------------------------------------|
| Global | 53.42 | 13043 ⁽⁴⁾ |
| Single | 56.46 | 13783 ⁽⁵⁾ |
| Dual | 59.89 | 14624 ⁽⁵⁾ |
| Quad | 61.39 | 14989 ⁽⁵⁾ |

(1) Refer to the DLPC910 data sheet in *Related Documentation* for a description of the reset modes.

(2) Pixel data rates are based on continuous streaming.

(3) Increasing exposure periods may be necessary for a desired application but may decrease pattern rate.

(4) Global reset mode allows for continuous or pulsed illumination source.

(5) This reset mode typically requires pulsed illumination such as a laser or LED.

STRUMENTS

XAS

7.10 System Mounting Interface Loads

| PARAMETER | | | NOM | MAX | UNIT |
|--|---------------------------------------|--|-----|-----|------|
| Maximum system mounting interface load to be applied to the: | Thermal interface area (See Figure 8) | | | 35 | lbs |
| | Electrical interface area | | | 300 | lbs |
| | Datum A interface area ⁽¹⁾ | | | 160 | lbs |

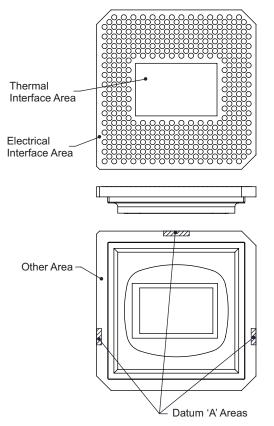


Figure 8. System Mounting Interface Loads

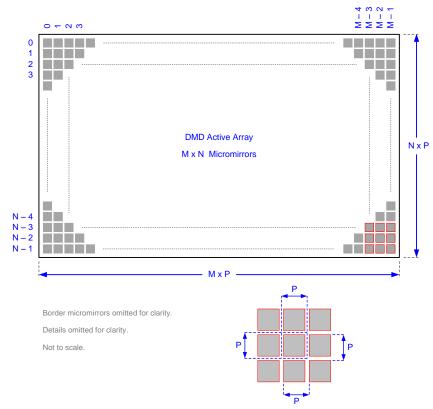
7.11 Micromirror Array Physical Characteristics

| | | | | VALUE | UNIT |
|---|---------------------------------|---|--------------|---------|--------------------|
| М | Number of active columns | | | 2560 | micromirrors |
| Ν | Number of active rows | | | 1600 | micromirrors |
| Ρ | Micromirror (pixel) pitch | | See Figure 9 | 7.56 | μm |
| | Micromirror active array width | M × P | | 19.3536 | mm |
| | Micromirror active array height | N×P | | 12.096 | mm |
| | Micromirror active border | Pond of micromirror (POM) (1) | | 14 | micromirrors/ side |
| | Micromirror total area | $P^2 \times M \times N$ (converted to cm) | | 2.341 | cm ² |

(1) Combined loads of the thermal and electrical interface areas in excess of Datum "A" load shall be evenly distributed outside the Datum *A* area (300 + 35 – Datum *A*).

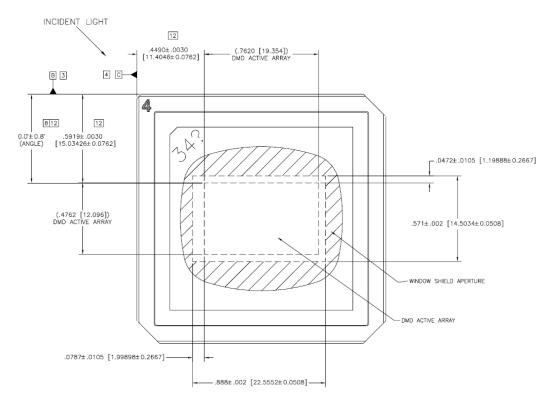
(1) The structure and qualities of the border around the active array includes a band of partially functional micromirrors called the POM. These micromirrors are structurally and/or electrically prevented from tilting toward the bright or ON state, but still require an electrical bias to tilt toward OFF.





Refer to section Micromirror Array Physical Characteristics table for M, N, and P specifications.

Figure 9. Micromirror Array Physical Characteristics





7.12 Micromirror Array Optical Characteristics

Refer to Optical Interface and System Image Quality for important information.

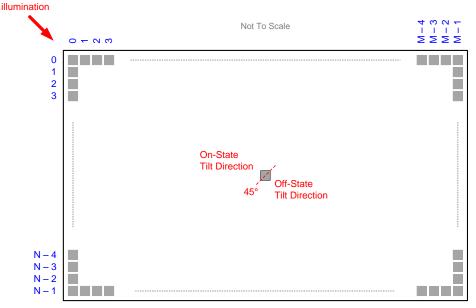
| | PARAMETER | TEST CONDITIONS | MIN | NOM | MAX | UNIT |
|---|--|---------------------------|-----|-----|-----|--------------|
| α | Micromirror tilt angle | DMD landed state (1) | | 12 | | 0 |
| β | Micromirror tilt angle tolerance (1) (2) (3) (4) (5) | | -1 | | 1 | o |
| | Micromirror tilt direction ⁽⁵⁾ ⁽⁶⁾ | See Figure 11 | 44 | 45 | 46 | o |
| | Number of out of one office time minor (7) | Adjacent micromirrors | | | 0 | |
| | Number of out-of-specification micromirrors ⁽⁷⁾ | Non-adjacent micromirrors | | | 10 | micromirrors |
| | Micromirror crossover time ^{(8) (9)} | Typical performance | | 2.5 | | μS |
| | DMD efficiency within the wavelength range 400 nm to 420 nm $^{(10)}$ | | | 68% | | |
| | DMD photopic efficiency within the wavelength range 420 nm to 700 nm $^{\rm (10)}$ | | | 66% | | |

(1) Measured relative to the plane formed by the overall micromirror array.

(2) Additional variation exists between the micromirror array and the package datums.

(3) Represents the landed tilt angle variation relative to the nominal landed tilt angle.

- (4) Represents the variation that can occur between any two individual micromirrors, located on the same device or located on different devices.
- (5) For some applications, it is critical to account for the micromirror tilt angle variation in the overall system optical design. With some system optical designs, the micromirror tilt angle variation within a device may result in perceivable non-uniformities in the light field reflected from the micromirror array. With some system optical designs, the micromirror tilt angle variations, the micromirror tilt angle variations, or system contrast variations.
- (6) When the micromirror array is landed (not parked), the tilt direction of each individual micromirror is dictated by the binary contents of the CMOS memory cell associated with each individual micromirror. A binary value of 1 results in a micromirror landing in the ON State direction. A binary value of 0 results in a micromirror landing in the OFF State direction.
- (7) An out-of-specification micromirror is defined as a micromirror that is unable to transition between the two landed states within the specified Micromirror Switching Time.
- (8) Micromirror crossover time is primarily a function of the natural response time of the micromirrors.
- (9) Performance as measured at the start of life.
- (10) Efficiency numbers assume 24-degree illumination angle, F/2.4 illumination and collection cones, uniform source spectrum, and uniform pupil illumination. Efficiency numbers assume 100% electronic mirror duty cycle and do not include optical overfill loss. Note that this number is specified under conditions described above and deviations from the specified conditions could result in decreased efficiency.



Refer to section Micromirror Array Physical Characteristics table for M, N, and P specifications.

Figure 11. Micromirror Landed Orientation and Tilt



7.13 Optical and System Image Quality

Optimizing system optical performance and image quality strongly relate to optical system design parameter trades. Although it is not possible to anticipate every conceivable application, projector image quality and optical performance is contingent on compliance to the optical system operating conditions described in a) through c) below:

- a. Numerical Aperture and Stray Light Control. The angle defined by the numerical aperture of the illumination and projection optics at the DMD optical area should be the same. This angle should not exceed the nominal device mirror tilt angle unless appropriate apertures are added in the illumination and/or projection pupils to block out flat-state and stray light from the projection lens. The mirror tilt angle defines DMD capability to separate the "ON" optical path from any other light path, including undesirable flat-state specular reflections from the DMD window, DMD border structures, or other system surfaces near the DMD such as prism or lens surfaces. If the numerical aperture exceeds the mirror tilt angle, or if the projection numerical aperture angle is more than two degrees larger than the illumination numerical aperture angle, objectionable artifacts in the display's border and/or active area could occur.
- b. Pupil Match. TI's optical and image quality specifications assume that the exit pupil of the illumination optics is nominally centered within two degrees of the entrance pupil of the projection optics. Misalignment of pupils can create objectionable artifacts in the display's border and/or active area, which may require additional system apertures to control, especially if the numerical aperture of the system exceeds the pixel tilt angle.
- c. Illumination Overfill. Overfill light illuminating the area outside the active array can create artifacts from the mechanical features that surround the active array and other surface anomalies that may be visible on the screen. The illumination optical system should be designed to limit light flux incident anywhere outside the active array more than 20 pixels from the edge of the active array on all sides. Depending on the particular system's optical architecture and assembly tolerances, this amount of overfill light on the outside of the active array may still cause artifacts to still be visible.

NOTE

TI ASSUMES NO RESPONSIBILITY FOR IMAGE QUALITY ARTIFACTS OR DMD FAILURES CAUSED BY OPTICAL SYSTEM OPERATING CONDITIONS EXCEEDING LIMITS DESCRIBED ABOVE.

| PARAMETER ⁽¹⁾ | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|---|-----|-------|-----|------|
| Window material designation | Corning 7056 | | | | |
| Window refractive index | at wavelength 589 nm | | 1.487 | | |
| Window aperture | See ⁽²⁾ | | | | |
| umination overfill Refer to Illumination Overfill | | | | | |
| | At wavelength 405 nm. Applies to 0° and 24° AOI only. | 95% | | | |
| Window transmittance, single–pass through both surfaces and glass $^{(3)}$ | Minimum within the wavelength range 420 nm to 680 nm. Applies to all angles 0° to 30° AOI. | 97% | | | |
| anough both outlabes and glass | Average over the wavelength range 420 nm to 680 nm. Applies to all angles 30° to 45° AOI. | 97% | | | |

7.14 Window Characteristics

(1) Refer to *Window Characteristics and Optics* for more information.

(2) For details regarding the size and location of the window aperture, refer to the package mechanical characteristics listed in the Mechanical ICD in the Mechanical, Packaging, and Orderable Information section.

(3) Refer to the TI application report DLPA031, Wavelength Transmittance Considerations for DMD Window.

7.15 Chipset Component Usage Specification

The DMD is a component of one or more DLP[®] chipsets. Reliable function and operation of the DMD requires that it be used in conjunction with the other components of the applicable DLP chipset, including those components that contain or implement TI DMD control technology. TI DMD control technology is the TI technology and devices for operating or controlling a DMD.



8 Parameter Measurement Information

The data sheet provides timing at the device pin. For output timing analysis, the tester pin electronics and its transmission line effects must be taken into account. Figure 12 shows an equivalent test load circuit for the output under test. The load capacitance value stated is only for characterization and measurement of AC timing signals. This load capacitance value does not indicate the maximum load the device is capable of driving.

Timing reference loads are not intended as a precise representation of any particular system environment or depiction of the actual load presented by a production test. System designers should use IBIS or other simulation tools to correlate the timing reference load to a system environment. Refer to the *Application and Implementation* section.

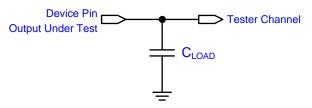


Figure 12. Test Load Circuit



9 Detailed Description

9.1 Overview

The DMD is a 0.9 inch diagonal spatial light modulator which consists of an array of highly reflective aluminum micromirrors. Pixel array size and square grid pixel arrangement are shown in Figure 9.

The DMD is an electrical input, optical output micro-electrical-mechanical system (MEMS). The electrical interface is Low Voltage Differential Signaling (LVDS), Double Data Rate (DDR).

The DMD consists of a two-dimensional array of 1-bit CMOS memory cells. The array is organized in a grid of *M* memory cell columns by *N* memory cell rows. Refer to the *Functional Block Diagram*.

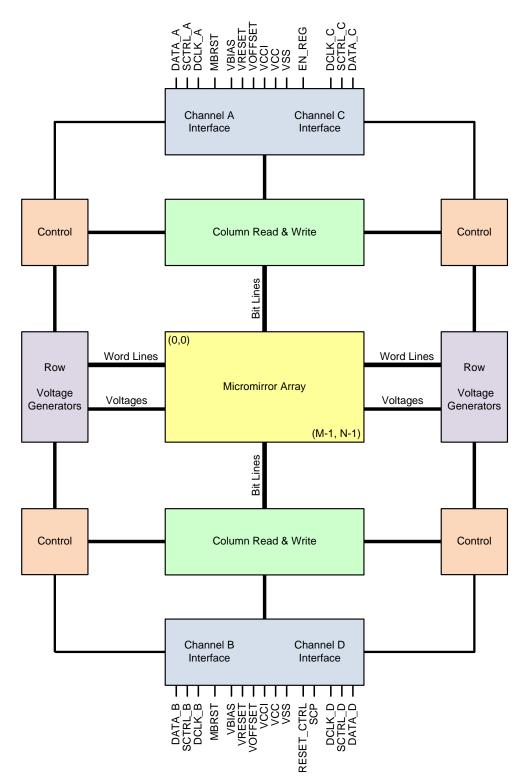
The positive or negative deflection angle of the micromirrors can be individually controlled by changing the address voltage of underlying CMOS addressing circuitry and micromirror reset signals (MBRST).

Each cell of the $M \times N$ memory array drives its true and complement ('Q' and 'QB') data to two electrodes underlying one micromirror, one electrode on each side of the diagonal axis of rotation. Refer to *Micromirror Array Optical Characteristics*. The micromirrors are electrically tied to the micromirror reset signals (MBRST) and the micromirror array is divided into reset groups.

Electrostatic potentials between a micromirror and its memory data electrodes cause the micromirror to tilt toward the illumination source in a DLP projection system or away from it, thus reflecting its incident light into or out of an optical collection aperture. The positive (+) tilt angle state corresponds to an 'on' pixel, and the negative (-) tilt angle state corresponds to an 'off' pixel.

Refer to *Micromirror Array Optical Characteristics* for the ± tilt angle specifications. Refer to *Pin Configuration and Functions* for more information on micromirror reset control.

9.2 Functional Block Diagram



Not to Scale. Details Omitted for Clarity. See Accompanying Notes in this Section.

For pin details on Channels A, B, C, and D, refer to *Pin Configuration and Functions* and LVDS Interface section of *Timing Requirements*.



9.3 Feature Description

The DMD consists of 4096000 highly reflective, digitally switchable, micrometer-sized mirrors (micromirrors) organized in a two-dimensional orthogonal pixel array. Refer to Figure 9 and Figure 13.

Each aluminum micromirror is switchable between two discrete angular positions, $-\alpha$ and $+\alpha$. The angular positions are measured relative to the micromirror array plane, which is parallel to the silicon substrate. Refer to *Micromirror Array Optical Characteristics* and Figure 14.

The parked position of the micromirror is not a latched position and is therefore not necessarily perfectly parallel to the array plane. Individual micromirror flat state angular positions may vary. Tilt direction of the micromirror is perpendicular to the hinge-axis. The on-state landed position is directed toward the left-top edge of the package, as shown in Figure 13.

Each individual micromirror is positioned over a corresponding CMOS memory cell. The angular position of a specific micromirror is determined by the binary state (logic 0 or 1) of the corresponding CMOS memory cell contents, after the mirror clocking pulse is applied. The angular position ($-\alpha$ and $+\alpha$) of the individual micromirrors changes synchronously with a micromirror clocking pulse, rather than being coincident with the CMOS memory cell data update.

Writing logic 1 into a memory cell followed by a mirror clocking pulse results in the corresponding micromirror switching to a $+\alpha$ position. Writing logic 0 into a memory cell followed by a mirror clocking pulse results in the corresponding micromirror switching to a $-\alpha$ position.

Updating the angular position of the micromirror array consists of two steps. First, update the contents of the CMOS memory. Second, apply a micromirror reset (also referred as Mirror Clocking Pulse) to all or a portion of the micromirror array (depending upon the configuration of the system). Micromirror reset pulses are generated internally by the DMD, with application of the pulses being coordinated by the DLPC900 or the DLPC910 digital controller.

For more information, refer to the TI application report DLPA008, DMD101: Introduction to Digital Micromirror Device (DMD) Technology.

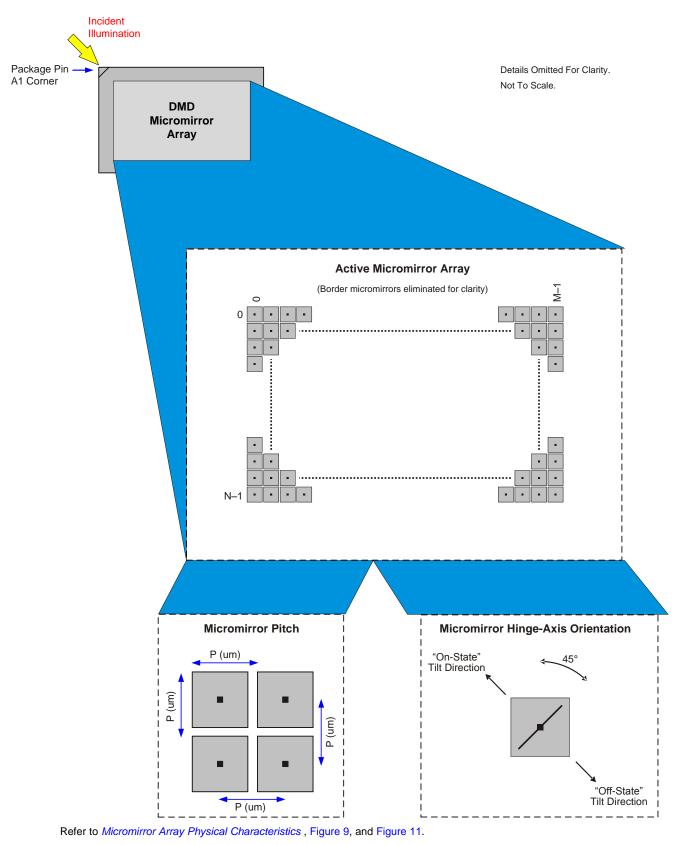
DLP9000

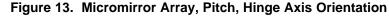
DLPS036B-SEPTEMBER 2014-REVISED OCTOBER 2016

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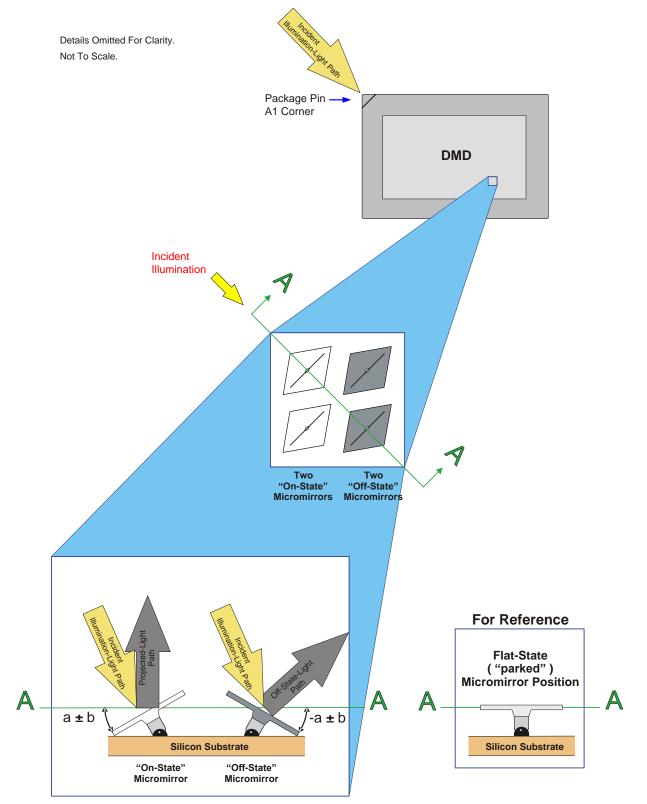
Feature Description (continued)



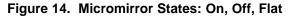




Feature Description (continued)



Micromirror States: On, Off, Flat





9.4 Device Functional Modes

9.4.1 DLP9000

The DLP9000 DMD is controlled by two DLPC900 digital controllers. The digital controller operates in two different modes. The first is video mode where the video source is displayed on the DMD. The second is Pattern mode, where the patterns are downloaded over USB or pre-stored in flash memory, and then streamed to the DMD. The resulting DMD pattern rate depends on which mode and bit-depth is selected. For more information, refer to the DLPC900 data sheet listed under *Related Documentation*.

9.4.2 DLP9000X

The DLP9000X DMD is controlled by one DLPC910 digital controller. The digital controller offers high speed streaming mode where 1-bit binary patterns are accepted at the LVDS interface input, and then streamed to the DMD. To ensure reliable operation, the DLP9000X must always be used with the DLPC910. For more information, refer to the DLPC910 data sheet listed under *Related Documentation*.

9.5 Window Characteristics and Optics

NOTE TI assumes no responsibility for image quality artifacts or DMD failures caused by optical

system operating conditions exceeding limits described previously.

9.5.1 Optical Interface and System Image Quality

TI assumes no responsibility for end-equipment optical performance. Achieving the desired end-equipment optical performance involves making trade-offs between numerous component and system design parameters. Optimizing system optical performance and image quality strongly relate to optical system design parameter trades. Although it is not possible to anticipate every conceivable application, projector image quality and optical performance is contingent on compliance to the optical system operating conditions described in the following sections.

9.5.2 Numerical Aperture and Stray Light Control

The angle defined by the numerical aperture of the illumination and projection optics at the DMD optical area should be the same. This angle should not exceed the nominal device mirror tilt angle unless appropriate apertures are added in the illumination and/or projection pupils to block out flat-state and stray light from the projection lens. The mirror tilt angle defines DMD capability to separate the "ON" optical path from any other light path, including undesirable flat-state specular reflections from the DMD window, DMD border structures, or other system surfaces near the DMD such as prism or lens surfaces. If the numerical aperture exceeds the mirror tilt angle, or if the projection numerical aperture angle is more than two degrees larger than the illumination numerical aperture angle, objectionable artifacts in the display's border and/or active area could occur.

9.5.3 Pupil Match

TI's optical and image quality specifications assume that the exit pupil of the illumination optics is nominally centered within 2° (two degrees) of the entrance pupil of the projection optics. Misalignment of pupils can create objectionable artifacts in the display's border and/or active area, which may require additional system apertures to control, especially if the numerical aperture of the system exceeds the pixel tilt angle.

9.5.4 Illumination Overfill

The active area of the device is surrounded by an aperture on the inside DMD window surface that masks structures of the DMD device assembly from normal view. The aperture is sized to anticipate several optical operating conditions. Overfill light illuminating the window aperture can create artifacts from the edge of the window aperture opening and other surface anomalies that may be visible on the screen. The illumination optical system should be designed to limit light flux incident anywhere on the window aperture from exceeding approximately 10% of the average flux level in the active area. Depending on the particular system's optical architecture, overfill light may have to be further reduced below the suggested 10% level in order to be acceptable.



9.6 Micromirror Array Temperature Calculation

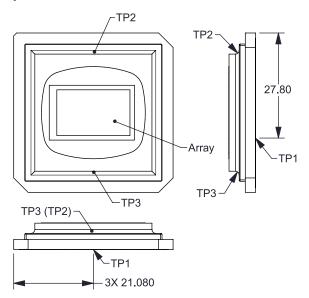


Figure 15. DMD Thermal Test Points

Micromirror array temperature can be computed analytically from measurement points on the outside of the package, the ceramic package thermal resistance, the electrical power dissipation, and the illumination heat load. The relationship between micromirror array temperature and the reference ceramic temperature is provided by the following equations:

| T _{ARRAY} = T _{CERAMIC} + (Q _{ARRAY} × R _{ARRAY-TO-CERAMIC}) | (1) |
|---|-----|
| $Q_{ARRAY} = Q_{ELECTRICAL} + Q_{ILLUMINATION}$ | (2) |
| $Q_{ILLUMINATION} = (C_{L2W} \times SL)$ | (3) |
| | |

Where:

 T_{ARRAY} = Computed micromirror array temperature (°C)

T_{CERAMIC} = Measured ceramic temperature (°C), TP1 location in Figure 15

 $R_{ARRAY-TO-CERAMIC}$ = DMD package thermal resistance from micromirror array to outside ceramic (°C/W) specified in *Thermal Information*

Q_{ARRAY} = Total DMD power; electrical, specified in *Electrical Characteristics*, plus absorbed (calculated) (W) Q_{ELECTRICAL} = DMD electrical power dissipation (W), specified in *Electrical Characteristics*

 C_{L2W} = Conversion constant for screen lumens to absorbed optical power on the DMD (W/Im) specified below

SL = Measured ANSI screen lumens (Im)

Electrical power dissipation of the DMD is variable and depends on the voltages, data rates and operating frequencies. Absorbed optical power from the illumination source is variable and depends on the operating state of the micromirrors and the intensity of the light source. Equations shown above produce a total projection efficiency through the projection lens from DMD to the screen of 87%.

The conversion constant CL2W is based on the DMD micromirror array characteristics. It assumes a spectral efficiency of 300 lm/W for the projected light and illumination distribution of 83.7% on the DMD active array, and 16.3% on the DMD array border and window aperture. The conversion constant is calculated to be 0.00274 W/lm.

Sample Calculation for typical projection application:

 $T_{CERAMIC} = 55^{\circ}C$, assumed system measurement; refer to *Recommended Operating Conditions* regarding specific limits.

SL = 2000 lm

 $Q_{ELECTRICAL} = 9.87W$ for the DLP9000 (refer to the power specifications in *Electrical Characteristics*) $C_{L2W} = 0.00274$ W/lm

Micromirror Array Temperature Calculation (continued)

 $\label{eq:Qarray} \begin{array}{l} Q_{ARRAY} = 9.87 \mbox{ W + } (0.00274 \mbox{ W/lm \times 2000 lm$}) = 15.35 \mbox{ W} \\ T_{ARRAY} = 55^{\circ}\mbox{C} + (15.35 \mbox{ W \times 0.5 $^{\circ}\mbox{C}/W$}) = 62.68^{\circ}\mbox{C} \end{array}$

9.7 Micromirror Landed-On/Landed-Off Duty Cycle

9.7.1 Definition of Micromirror Landed-On/Landed-Off Duty Cycle

The micromirror landed-on/landed-off duty cycle (landed duty cycle) denotes the amount of time (as a percentage) that an individual micromirror is landed in the On–state versus the amount of time the same micromirror is landed in the Off–state.

As an example, a landed duty cycle of 100/0 indicates that the referenced pixel is in the On-state 100% of the time (and in the Off-state 0% of the time); whereas 0/100 would indicate that the pixel is in the Off-state 100% of the time. Likewise, 50/50 indicates that the pixel is On 50% of the time and Off 50% of the time.

Note that when assessing landed duty cycle, the time spent switching from one state (ON or OFF) to the other state (OFF or ON) is considered negligible and is thus ignored.

Since a micromirror can only be landed in one state or the other (On or Off), the two numbers (percentages) always add to 100.

9.7.2 Landed Duty Cycle and Useful Life of the DMD

Knowing the long-term average landed duty cycle (of the end product or application) is important because subjecting all (or a portion) of the DMD's micromirror array (also called the active array) to an asymmetric landed duty cycle for a prolonged period of time can reduce the DMD's usable life.

Note that it is the symmetry/asymmetry of the landed duty cycle that is of relevance. The symmetry of the landed duty cycle is determined by how close the two numbers (percentages) are to being equal. For example, a landed duty cycle of 50/50 is perfectly symmetrical whereas a landed duty cycle of 100/0 or 0/100 is perfectly asymmetrical.

Individual DMD mirror duty cycles vary by application as well as the mirror location on the DMD within any specific application. DMD mirror useful life are maximized when every individual mirror within a DMD approaches 50/50 (or 1/1) duty cycle. Therefore, for the DLPC900 and DLP9000 chipset, it is recommended that *DMD Idle Mode* be enabled as often as possible. Examples are whenever the system is idle, the illumination is disabled, between sequential pattern exposures (if possible), or when the exposure pattern sequence is stopped for any reason. This software mode provides a 50/50 duty cycle across the entire DMD mirror array, where the mirrors are continuously flipped between the on and off states. Refer to the DLPC900 Programmer's Guide DLPU018 for a description of the *DMD Idle Mode* command. For the DLPC910 and DLP9000X chipset, it is recommended the controlling applications processor provide a 50/50 pattern sequence to the DLPC910 for display on the DLP9000X as often as possible, similar to the above examples stated for the DLPC900. The pattern provides a 50/50 duty cycle across the entire DMD mirror array, where the on and off states.

9.7.3 Landed Duty Cycle and Operational DMD Temperature

Operational DMD Temperature and Landed Duty Cycle interact to affect the DMD's usable life, and this interaction can be exploited to reduce the impact that an asymmetrical Landed Duty Cycle has on the DMD's usable life. This is quantified in the de-rating curve shown in Figure 16. The importance of this curve is that:

- All points along this curve represent the same usable life.
- All points above this curve represent lower usable life (and the further away from the curve, the lower the usable life).
- All points below this curve represent higher usable life (and the further away from the curve, the higher the usable life).

In practice, this curve specifies the Maximum Operating DMD Temperature that the DMD should be operated at for a give long-term average Landed Duty Cycle.



Micromirror Landed-On/Landed-Off Duty Cycle (continued)

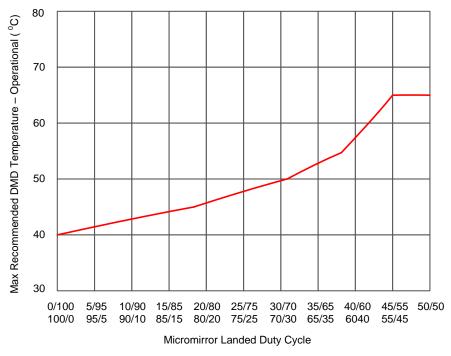


Figure 16. Max Recommended DMD Temperature – Derating Curve

9.7.4 Estimating the Long-Term Average Landed Duty Cycle of a Product or Application

During a given period of time, the Landed Duty Cycle of a given pixel follows from the image content being displayed by that pixel.

For example, in the simplest case, when displaying pure-white on a given pixel for a given time period, that pixel will experience a 100/0 Landed Duty Cycle during that time period. Likewise, when displaying pure-black, the pixel will experience a 0/100 Landed Duty Cycle.

Between the two extremes (ignoring for the moment color and any image processing that may be applied to an incoming image), the Landed Duty Cycle tracks one-to-one with the gray scale value, as shown in Table 3.

| • | |
|-----------------|-------------------|
| GRAYSCALE VALUE | LANDED DUTY CYCLE |
| 0% | 0/100 |
| 10% | 10/90 |
| 20% | 20/80 |
| 30% | 30/70 |
| 40% | 40/60 |
| 50% | 50/50 |
| 60% | 60/40 |
| 70% | 70/30 |
| 80% | 80/20 |
| 90% | 90/10 |
| 100% | 100/0 |
| | |

Table 3. Grayscale Value and Landed Duty Cycle

Accounting for color rendition (but still ignoring image processing) requires knowing both the color intensity (from 0% to 100%) for each constituent primary color (red, green, and/or blue) for the given pixel as well as the color cycle time for each primary color, where "color cycle time" is the total percentage of the frame time that a given primary must be displayed in order to achieve the desired white point.

During a given period of time, the landed duty cycle of a given pixel can be calculated as follows:

Landed Duty Cycle = (Red_Cycle_% × Red_Scale_Value) + (Green_Cycle_% × Green_Scale_Value) + (Blue_Cycle_% × Blue_Scale_Value)

Where:

Red_Cycle_%, Green_Cycle_%, and Blue_Cycle_%, represent the percentage of the frame time that Red, Green, and Blue are displayed (respectively) to achieve the desired white point.

For example, assume that the red, green and blue color cycle times are 50%, 20%, and 30% respectively (in order to achieve the desired white point), then the Landed Duty Cycle for various combinations of red, green, blue color intensities would be as shown in Table 4.

| RED CYCLE PERCENTAGE 50% | GREEN CYCLE PERCENTAGE 20% | BLUE CYCLE PERCENTAGE 30% | LANDED DUTY CYCLE |
|-----------------------------|----------------------------|------------------------------|-------------------|
| RED SCALE VALUE | GREEN SCALE VALUE | BLUE SCALE VALUE | |
| 0% | 0% | 0% | 0/100 |
| 100% | 0% | 0% | 50/50 |
| 0% | 100% | 0% | 20/80 |
| 0% | 0% | 100% | 30/70 |
| 12% | 0% | 0% | 6/94 |
| 0% | 35% | 0% | 7/93 |
| 0% | 0% | 60% | 18/82 |
| 100% | 100% | 0% | 70/30 |
| 0% | 100% | 100% | 50/50 |
| 100% | 0% | 100% | 80/20 |
| 12% | 35% | 0% | 13/87 |
| 0% | 35% | 60% | 25/75 |
| 12% | 0% | 60% | 24/76 |
| 100% | 100% | 100% | 100/0 |

Table 4. Example Landed Duty Cycle for Full-Color



10 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

10.1 Application Information

The DLP9000 DMD is controlled by two DLPC900 controllers. This chipset offers two modes of operation. The first is video mode where the video source is displayed on the DMD. The second is Pattern mode, where the patterns are pre-stored in flash memory and then streamed to the DMD. The allowed DMD pattern rate depends on which mode and bit-depth is selected.

The DLP9000X DMD is controlled by the DLPC910 controller, where the DLPC910 is configured by the program content in the DLPR910. This chipset offers streaming 1-bit binary patterns to the DMD at speeds greater than 61 Gigabits per second (Gbps). The patterns are streamed from an customer designed processor into the DLPC910 LVDS input data interface.

Both the DLP9000 and the DLP9000X provide solutions for many varied applications including structured light, 3-D printing, video projection, and high speed lithography. The DMD is a spatial light modulator, which reflects incoming light from an illumination source to one of two directions, with the primary direction being into a projection or collection optic. Each application is derived primarily from the optical architecture of the system and the format of the data being used.

10.2 Typical Applications

10.2.1 Typical Application using DLP9000

A typical embedded system application using two DLPC900 controllers and a DLP9000 DMD is shown in Figure 17. In this configuration, the DLPC900 controller supports a 24-bit parallel RGB input, typical of LCD interfaces, from an external source or processor. The 24-bit parallel data must be split between a left half and a right half, each half between the two controllers. The external processor must format each half to consist of 1280x1600 plus any horizontal and vertical blanking at half the pixel clock rate. This system configuration supports still and motion video as well as sequential pattern modes. For more information, refer to the DLPC900 digital controller data sheet listed under *Related Documentation*.



Typical Applications (continued)

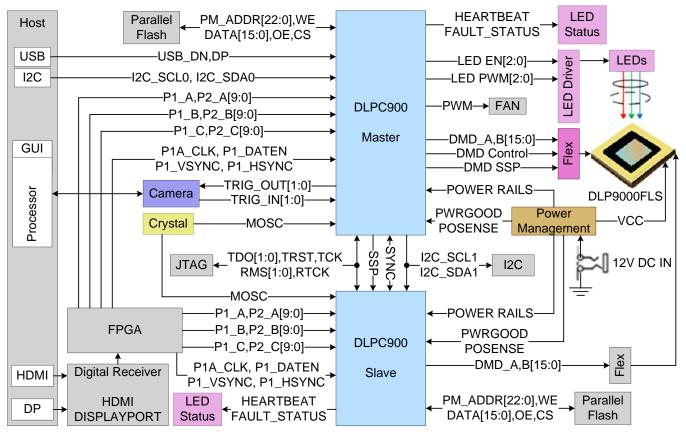


Figure 17. DLP9000 Typical Application Schematic

10.2.1.1 Design Requirements

Detailed design requirements are located in the DLPC900 or the DLPC910 digital controller data sheets. Refer to the data sheets listed under *Related Documentation*.

10.2.1.2 Detailed Design Procedure

Reference Design material exists for systems using either the DLP9000 or the DLP9000X DMD with their respective Controllers. This reference material includes reference board schematics, PCB layouts, and Bills of Materials. Layout guidelines for boards utilizing these controllers and DMDs can be found in the respective DLPC900 or DLPC910 Controller data sheets. For more information, please refer to the individual controller data sheets listed under *Related Documentation*.

10.2.2 Typical Application Using DLP9000X

Direct-write digital imaging is regularly used in high-end lithography printing. This mask-less technology offers a continuous run of printing by changing the digitally created patterns without stopping the imaging head. Figure 18 shows a system where a DLPC910 digital controller is coupled with the DLP9000X DMD. This system offers an ideal back-end imager that takes in digital images at 2560 x 1600 in resolution to achieve speeds of more than 61 Gbps. For more information, refer to the DLPC910 digital controller data sheet listed under *Related Documentation*.



Typical Applications (continued)

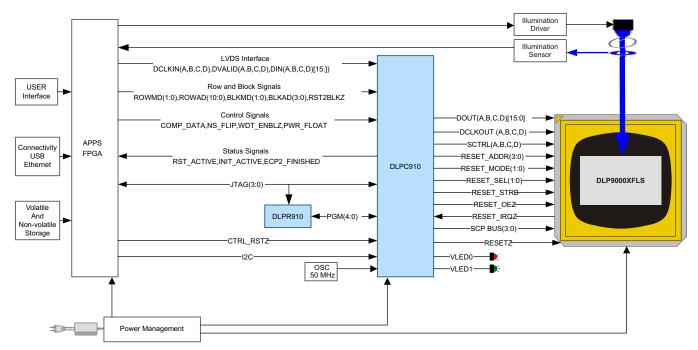


Figure 18. DLP9000X Typical Application Schematic



11 Power Supply Requirements

11.1 DMD Power Supply Requirements

The following power supplies are all required to operate the DMD: VCC, VCCI, VOFFSET, VBIAS, and VRESET. VSS must also be connected. DMD power-up and power-down sequencing is strictly controlled by the DLPC900 or DLPC910 Controllers within their associated reference designs.

CAUTION

For reliable operation of the DMD, the following power supply sequencing requirements must be followed. Failure to adhere to the prescribed power-up and power-down procedures may affect device reliability. VCC, VCCI, VOFFSET, VBIAS, and VRESET power supplies have to be coordinated during power-up and power-down operations. VSS must also be connected. Failure to meet any of the below requirements will result in a significant reduction in the DMD's reliability and lifetime. Refer to Figure 19.

11.2 DMD Power Supply Power-Up Procedure

- During power-up, VCC and VCCI must always start and settle before VOFFSET, VBIAS, and VRESET voltages are applied to the DMD.
- During power-up, it is a strict requirement that the delta between VBIAS and VOFFSET must be within the specified limit shown in *Recommended Operating Conditions*. During power-up, VBIAS does not have to start after VOFFSET.
- During power-up, there is no requirement for the relative timing of VRESET with respect to VOFFSET and VBIAS.
- Power supply slew rates requirements during power-up are flexible, provided that the transient voltage levels follow the requirements listed in *Absolute Maximum Ratings*, in *Recommended Operating Conditions*, and in Figure 19.
- During power-up, LVCMOS input pins shall not be driven high until after VCC and VCCI have settled at operating voltages listed in *Recommended Operating Conditions*.



11.3 DMD Mirror Park Sequence Requirements

11.3.1 DLP9000

For correct power down operation of the DLP9000 DMD, the following power down procedure must be executed.

Prior to an anticipated power removal, the controlling applications processor must command the DLPC900 to enter Standby mode by using the *Power Mode* command and then wait for a minimum of 20 ms to allow the DLPC900 to complete the power down procedure. This procedure will assure the mirrors are in a flat state. Following this procedure, the power can be safely removed.

In the event of an unanticipated power loss, the power management system must detect the input power loss, command the DLPC900 to enter Standby mode by using the *Power Mode* command, and then maintain all operating power levels of the DLPC900 and the DLP9000 DMD for a minimum of 20 ms to allow the DLPC900 to complete the power down procedure. Following this procedure, the power can be allowed to fall below safe operating levels. Refer to the DLPC900 datasheet for more details on power down requirements.

In both anticipated power down and unanticipated power loss, the DLPC900 is commanded over the USB/I2C interface, and then the DLPC900 loads the correct power down sequence to the DMD. Communicating over the USB/I2C and loading the power down sequence accounts for most of the 20 ms. Compared to the DLPC910, the controlling processor only needs to assert the PWR_FLOAT pin and wait for a minimum of 500 µs.

The controlling applications processor can resume normal operations by commanding the DLPC900 to enter Normal mode. See *Power Mode* command in the DLPC900 Programmer's Guide DLPU018 for a description of this command.

11.3.2 DLP9000X

For correct power down operation of the DLP9000X DMD, the following power down procedure must be executed.

Prior to an anticipated power removal, assert PWR_FLOAT to the DLPC910 for a minimum of 500 μ s to allow the DLPC910 to complete the power down procedure. This procedure will assure the DMD mirrors are in a flat state. Following this procedure, the power can be safely removed.

In the event of an unanticipated power loss, the power management system must detect the input power loss, assert PWR_FLOAT to the DLPC910, and maintain all operating power levels of the DLPC910 and the DLP9000X DMD for a minimum of 500 μ s to allow the DLPC910 to complete the power down procedure. Refer to the DLPC910 datasheet for more details on power down requirements.

To restart after assertion of PWR_FLOAT without removing power, the DLPC910 must be reset by setting CTRL_RSTZ low (logic 0) for 50 ms, and then back to high (logic 1), or power to the DLPC910 must be cycled.

11.4 DMD Power Supply Power-Down Procedure

- During power-down, VCC and VCCI must be supplied until after VBIAS, VRESET, and VOFFSET are discharged to within the specified limit of ground. Refer to Table 5.
- During power-down, it is a strict requirement that the delta between VBIAS and VOFFSET must be within the specified limit shown in *Recommended Operating Conditions*. During power-down, it is not mandatory to stop driving VBIAS prior to VOFFSET.
- During power-down, there is no requirement for the relative timing of VRESET with respect to VOFFSET and VBIAS.
- Power supply slew rates during power-down are flexible, provided that the transient voltage levels follow the requirements listed in *Absolute Maximum Ratings*, in *Recommended Operating Conditions*, and in *Figure 19*.
- During power-down, LVCMOS input pins must be less than specified in *Recommended Operating Conditions*.

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DMD Power Supply Power-Down Procedure (continued)

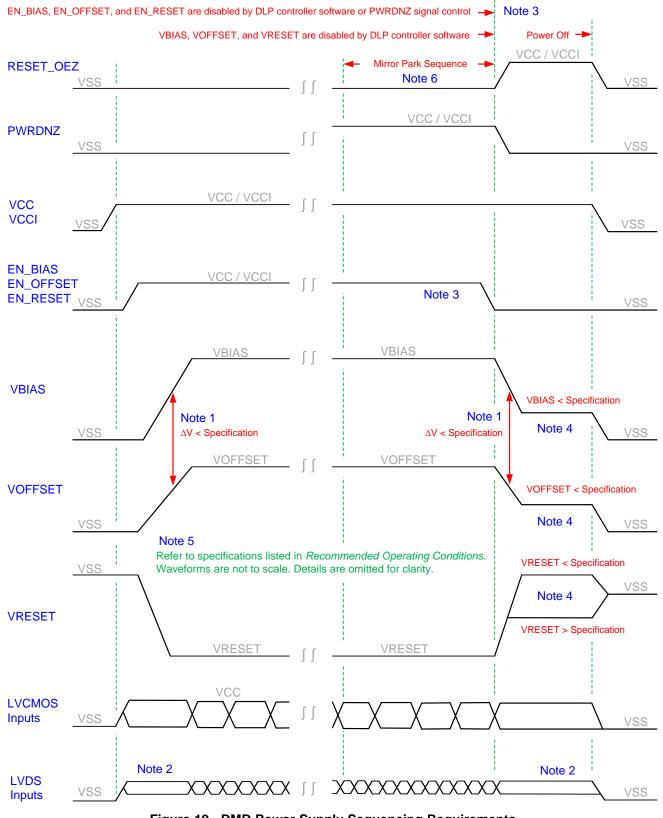


Figure 19. DMD Power Supply Sequencing Requirements



DMD Power Supply Power-Down Procedure (continued)

- 1. To prevent excess current, the supply voltage delta |VBIAS VOFFSET| must be less than specified in *Recommended Operating Conditions.* OEMs may find that the most reliable way to ensure this is to power VOFFSET prior to VBIAS during power-up and to remove VBIAS prior to VOFFSET during power-down.
- During power-up, the LVDS signals are less than the input differential voltage (VID) maximum specified in <u>Recommended Operating Conditions</u>. During power-down, LVDS signals are less than the high level input voltage (VIH) maximum specified in <u>Recommended Operating Conditions</u>.
- 3. When system power is interrupted, the DLPC900 and the DLPC910 controllers initiate a hardware powerdown that activates PWRDNZ and disables VBIAS, VRESET and VOFFSET after the micromirror park sequence. Software power-down disables VBIAS, VRESET, and VOFFSET after the micromirror park sequence through software control. For either case, enable signals EN_BIAS, EN_OFFSET, and EN_RESET are used to disable VBIAS, VOFFSET, and VRESET, respectively.

4. Refer to Table 5.

- 5. Figure not to scale. Details have been omitted for clarity. Refer to *Recommended Operating Conditions*.
- 6. Refer to *DMD Mirror Park Sequence Requirements* for details on powering down the DMD.

Table 5. DMD Power-Down Sequence Requirements

| | MIN | MAX | UNIT | |
|---------|---|------|------|---|
| VBIAS | | | 4.0 | V |
| VOFFSET | Supply voltage level during power-down sequence | | 4.0 | V |
| VRESET | | -4.0 | 0.5 | V |



12 Layout

12.1 Layout Guidelines

Each chipset provides a solution for many applications including structured light and video projection. This section provides layout guidelines for the DMD.

12.1.1 General PCB Recommendations

The PCB shall be designed to IPC2221 and IPC2222, Class 2, Type Z, at level B producibility and built to IPC6011 and IPC6012, class 2. The PCB board thickness to be 0.062 inches ±10%, using a dielectric material with a low Loss-Tangent, for example: Hitachi 679gs or equivalent.

Two-ounce copper planes are recommended in the PCB design in order to achieve needed thermal connectivity. Refer to the digital controller data sheets listed under *Related Documentation* regarding DMD Interface Considerations.

High-speed interface waveform quality and timing on the digital controllers (that is, the LVDS DMD interface) is dependent on the following factors:

- Total length of the interconnect system
- Spacing between traces
- Characteristic impedance
- Etch losses
- How well matched the lengths are across the interface

Thus, ensuring positive timing margin requires attention to many factors.

As an example, DMD interface system timing margin can be calculated as follows:

- Setup Margin = (controller output setup) (DMD input setup) (PCB routing mismatch) (PCB SI degradation)
- Hold-time Margin = (controller output hold) (DMD input hold) (PCB routing mismatch) (PCB SI degradation)

The PCB SI degradation is the signal integrity degradation due to PCB affects which includes such things as simultaneously switching output (SSO) noise, crosstalk, and inter-symbol-interference (ISI) noise.

Both the DLPC910 and the DLPC900 I/O timing parameters can be found in their respective data sheets. Similarly, PCB routing mismatch can be easily budgeted and met via controlled PCB routing. However, PCB SI degradation is not as easy to determine.

In an attempt to minimize the signal integrity analysis that would otherwise be required, the following PCB design guidelines provide a reference of an interconnect system that satisfies both waveform quality and timing requirements (accounting for both PCB routing mismatch and PCB SI degradation). Deviation from these recommendations should be confirmed with PCB signal integrity analysis or lab measurements.

12.1.2 Power Planes

Signal routing is NOT allowed on the power and ground planes. All device pin and via connections to this plane shall use a thermal relief with a minimum of four spokes. The power plane shall clear the edge of the PCB by 0.2".

Prior to routing, vias connecting all digital ground layers (GND) should be placed around the edge of the rigid PWB regions 0.025" from the board edges with a 0.100" spacing. It is also desirable to have all internal digital ground (GND) planes connected together in as many places as possible. If possible, all internal ground planes should be connected together with a minimum distance between connections of 0.5". Extra vias are not required if there are sufficient ground vias due to normal ground connections of devices. NOTE: All signal routing and signal vias should be inside the perimeter ring of ground vias.

Power and Ground pins of each component shall be connected to the power and ground planes with one via for each pin. Trace lengths for component power and ground pins should be minimized (ideally, less than 0.100"). Unused or spare device pins that are connected to power or ground may be connected together with a single via to power or ground. Ground plane slots are NOT allowed.

Route VOFFSET, VBIAS, and VRESET as a wide trace >20 mils (wider if space allows) with 20 mils spacing.



Layout Guidelines (continued)

12.1.3 LVDS Signals

The LVDS signals shall be first. Each pair of differential signals must be routed together at a constant separation such that constant differential impedance (as in section *Board Stack and Impedance Requirements*) is maintained throughout the length. Avoid sharp turns and layer switching while keeping lengths to a minimum. The distance from one pair of differential signals to another shall be at least 2 times the distance within the pair.

12.1.4 Critical Signals

The critical signals on the board must be hand routed in the order specified below. In case of length matching requirements, the longer signals should be routed in a serpentine fashion, keeping the number of turns to a minimum and the turn angles no sharper than 45 degrees. Avoid routing long trace all around the PCB.

| GROUP | SIGNAL | CONSTRAINTS | ROUTING LAYERS |
|-------|--|--------------------------------|---|
| 1 | D_AP(0:15), D_AN(0:15), DCLK_AP, DCLK_AN, SCTRL_AN, SCTRL_AP, D_BP(0:15), D_BN(0:15), DCLK_BP, DCLK_BN, SCTRL_BN, SCTRL_BP, D_CP(0:15), D_CN(0:15), DCLK_CP, DCLK_CN, SCTRL_CN, SCTRL_CP, D_DP(0:15), D_DN(0:15), DCLK_DP, DCLK_DN, SCTRL_DN, SCTRL_DP. | | Internal signal layers. Avoid layer switching when routing these signals. |
| 2 | RESET_ADDR_(0:3), RESET_MODE_(0:1), RESET_OEZ, RESET_SEL_(0:1) RESET_STROBE, RESET_IRQZ. | Refer to Table 7 and Table 8 | Internal signal layers. Top and bottom as required. |
| 3 | SCP_CLK, SCP_DO, SCP_DI, SCP_DMD_CSZ. | - | Any |
| 4 | Others | No matching/length requirement | Any |

12.1.5 Flex Connector Plating

Plate all the pad area on top layer of flex connection with a minimum of 35 and maximum 50 micro-inches of electrolytic hard gold over a minimum of 150 micro-inches of electrolytic nickel.

12.1.6 Device Placement

Unless otherwise specified, all major components should be placed on top layer. Small components such as ceramic, non-polarized capacitors, resistors and resistor networks can be placed on bottom layer. All high frequency de-coupling capacitors for the ICs shall be placed near the parts. Distribute the capacitors evenly around the IC and locate them as close to the device's power pins as possible (preferably with no vias). In the case where an IC has multiple de-coupling capacitors with different values, alternate the values of those that are side by side as much as possible and place the smaller value capacitor closer to the device.

12.1.7 Device Orientation

It is desirable to have all polarized capacitors oriented with their positive terminals in the same direction. If polarized capacitors are oriented both horizontally and vertically, then all horizontal capacitors should be oriented with the "+" terminal the same direction and likewise for the vertically oriented ones.

12.1.8 Fiducials

Fiducials for automatic component insertion should be placed on the board according to the following guidelines or on recommendation from manufacturer:

- Fiducials for optical auto insertion alignment shall be placed on three corners of both sides of the PWB.
- Fiducials shall also be placed in the center of the land patterns for fine pitch components (lead spacing <0.05").
- Fiducials should be 0.050 inch copper with 0.100 inch cutout (antipad).

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12.2 Layout Example

12.2.1 Board Stack and Impedance Requirements

Refer to Figure 20 regarding guidance on the parameters.

PCB design:

| Configuration: | Asymmetric dual stripline |
|--------------------------------|---------------------------|
| Etch thickness (T): | 1.0-oz copper (1.2 mil) |
| Flex etch thickness (T): | 0.5-oz copper (0.6 mil) |
| Single-ended signal impedance: | 50 Ω (±10%) |
| Differential signal impedance: | 100 Ω (±10%) |

PCB stack-up:

Reference plane 1 is assumed to be a ground plane for proper return path.

Reference plane 2 is assumed to be the I/O power plane or ground.

| Dielectric material with a low Loss-Tangent, for example: Hitachi 679gs or equivalent. | (Er): 3.8 (nominal) |
|--|---------------------|
| Signal trace distance to reference plane 1 (H1): | 5.0 mil (nominal) |
| Signal trace distance to reference plane 2 (H2): | 34.2 mil (nominal) |



Layout Example (continued)

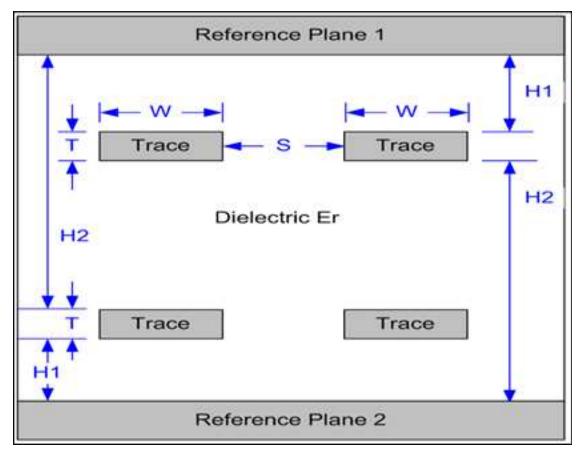


Figure 20. PCB Stack Geometries

Layout Example (continued)

Table 7. General PCB Routing (Applies to All Corresponding PCB Signals)

| PARAMETER | APPLICATION | SINGLE-ENDED SIGNALS | DIFFERENTIAL PAIRS | UNIT | | | | |
|--|------------------------------|----------------------|------------------------------|-------------|--|--|--|--|
| | Escape routing in ball field | 4 .4 (0.1) | 4 .3 (0.1) | mil (mm) | | | | |
| Line width (W) | PCB etch data or control | 7 (0.18) | 4.25 (0.11) | mil (mm) | | | | |
| | PCB etch clocks | 7 (0.18) | 4.25 (0.11) | mil (mm) | | | | |
| | PCB etch data or control | N/A | 5.75 ⁽¹⁾ -0.15 | mil (mm) | | | | |
| Differential signal pair spacing (S) | PCB etch clocks | N/A | 5.75 ⁽¹⁾ -0.15 | mil (mm) | | | | |
| Minimum differential pair-to-pair | PCB etch data or control | N/A | 20 (0.51) | mil (mm) | | | | |
| spacing (S) | PCB etch clocks | N/A | 20 (0.51) | mil (mm) | | | | |
| | Escape routing in ball field | 4 (0.1) | 4 (0.1) | mil (mm) | | | | |
| Minimum line spacing to other signals (S) | PCB etch data or control | 10 (0.25) | 20 (0.51) | mil (mm) | | | | |
| | PCB etch clocks | 20 (0.51) | 20 (0.51) | mil (mm) | | | | |
| Maximum differential pair P-to-N length mismatch | Total data | N/A | 10 0.25 | mil (mm) | | | | |
| | Total data | N/A | 10 0.25 | mil (mm) | | | | |

(1) Spacing may vary to maintain differential impedance requirements

Table 8. DMD Interface Specific Routing

| | SIGNAL GROUP LENGTH MATCHING | | | | | | | | | |
|------------|---|----------------|-----------------|-------------|--|--|--|--|--|--|
| INTERFACE | REFERENCE SIGNAL | MAX MISMATCH | UNIT | | | | | | | |
| DMD (LVDS) | SCTRL_AN / SCTRL_AP D_AP(15:0)/ D_AN(15:0) | DCKA_P/ DCKA_N | ± 50 (± 1.3) | mil (mm) | | | | | | |
| DMD (LVDS) | SCTRL_BN/ SCTRL_BP D_BP(15:0)/ D_BN(15:0) | DCKB_P/ DCKB_N | ± 50 (± 1.3) | mil (mm) | | | | | | |
| DMD (LVDS) | SCTRL_CN/ SCTRL_CP D_CP(15:0)/ D_CN(15:0) | DCK_CP/ DCK_CN | ± 50 (± 1.3) | mil (mm) | | | | | | |
| DMD (LVDS) | SCTRL_DN/ SCTRL_DP D_DP(15:0)/ D_DN(15:0) | DCK_CP/ DCK_CN | ± 50 (± 1.3) | mil (mm) | | | | | | |

Number of layer changes:

- Single-ended signals: Minimize
- Differential signals: Individual differential pairs can be routed on different layers but the signals of a given pair should not change layers.

| Table | 9. DMD Signal Rout | ing Len | gth ⁽¹⁾ |
|-------|--------------------|---------|--------------------|
| BUS | MIN | MAX | UNIT |

| BUS | MIN | MAX | UNIT |
|------------|-----|-----|------|
| DMD (LVDS) | 50 | 375 | mm |

(1) Max signal routing length includes escape routing.



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Stubs: Stubs should be avoided.

Termination Requirements: DMD interface: None – The DMD receiver is differentially terminated to 100 Ω internally.

Connector (DMD-LVDS interface bus only):

High-speed connectors that meet the following requirements should be used:

- Differential crosstalk: <5%
- Differential impedance: 75 to 125 Ω

Routing requirements for right-angle connectors: When using right-angle connectors, P-N pairs should be routed in the same row to minimize delay mismatch. When using right-angle connectors, propagation delay difference for each row should be accounted for on associated PCB etch lengths. Voltage or low frequency signals should be routed on the outer layers. Signal trace corners shall be no sharper than 45 degrees. Adjacent signal layers shall have the predominant traces routed orthogonal to each other.

13 Device and Documentation Support

13.1 Device Support

13.1.1 Device Handling

All external signals on the DMD are protected from damage by electrostatic discharge, and are tested in accordance with JESD22-A114-B electrostatic discharge (ESD) sensitivity testing human body model (HBM).

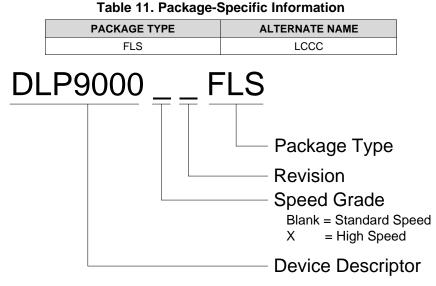
| PACKAGE TERMINAL TYPE | VOLTAGE (MAXIMUM) | UNIT |
|-----------------------|-------------------|------|
| Input | 2000 | V |
| Output | 2000 | V |
| VCC | 2000 | V |
| VCCI | 2000 | V |
| VOFFSET | 2000 | V |
| VBIAS | 2000 | V |
| VRESET | 2000 | V |
| All MBRST | 2000 | V |

Table 10. DMD ESD Protection Limits

All CMOS devices require proper Electrostatic Discharge (ESD) handling procedures. Refer to drawing 2504641 DMD Handling Specification, for precautions to protect the DMD from ESD and to protect the DMD's glass and electrical contacts. Refer to drawing 2504640 DMD Glass Cleaning Procedure, for correct and consistent methods for cleaning the glass of the DMD, in such a way that the anti-reflective coatings on the glass surface are not damaged.

13.1.2 Device Nomenclature

Figure 21 provides a legend for reading the complete device name for any DLP device.





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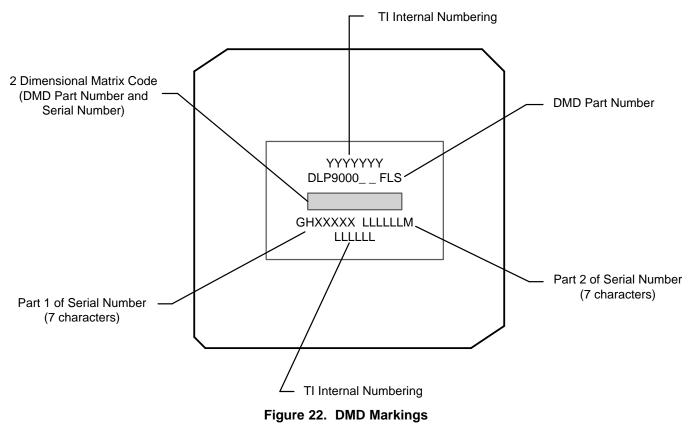
STRUMENTS



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13.1.3 Device Markings

The device marking will include both human-readable information and a 2-dimensional matrix code. The humanreadable information is described in Figure 22. The 2-dimensional matrix code is an alpha-numeric character string that contains the DMD part number, Part 1 of Serial Number, and Part 2 of Serial Number. The first character of the DMD Serial Number (part 1) is the manufacturing year. The second character of the DMD Serial Number (part 1) is the manufacturing month. The last character of the DMD Serial Number (part 2) is the bias voltage bin letter.



13.2 Documentation Support

13.2.1 Related Documentation

The following documents contain additional information related to the use of the DLP9000 family of devices:

- DLPC900 Digital Controller Data Sheet (DLPS037)
- DLPC900 Software Programmer's Guide (DLPU018)
- DLPC910 Digital Controller Data Sheet (DLPS064)
- DLPR910 Configuration PROM Data Sheet (DLPS065)

13.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E[™] Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.



13.4 Trademarks

E2E is a trademark of Texas Instruments. DLP is a registered trademark of Texas Instruments. All other trademarks are the property of their respective owners.

13.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

13.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

14.1 Thermal Characteristics

Achieving optimal DMD performance requires proper management of the maximum DMD case temperature, the maximum temperature of any individual micromirror in the active array and the temperature gradient between any two points on or within the package.

Refer to *Absolute Maximum Ratings* and *Recommended Operating Conditions* regarding applicable temperature limits.

14.2 Package Thermal Resistance

The DMD is designed to conduct the absorbed and dissipated heat back to the series FLS package where it can be removed by an appropriate thermal management system. The thermal management system must be capable of maintaining the package within the specified operational temperatures at the thermal test point locations (refer to Figure 15 or *Micromirror Array Temperature Calculation*). The total heat load on the DMD is typically driven by the incident light absorbed by the active area; although other contributions can include light energy absorbed by the window aperture, electrical power dissipation of the array, and parasitic heating. For the thermal resistance, refer to *Thermal Information*.

14.3 Case Temperature

The temperature of the DMD case can be measured directly. For consistency, a thermal test point location is defined as shown in Figure 15 and *Micromirror Array Temperature Calculation*.



10-Dec-2020

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|---------|
| DLP9000BFLS | ACTIVE | CLGA | FLS | 355 | 1 | RoHS & Green | NI-PD-AU | N / A for Pkg Type | | | Samples |
| DLP9000XBFLS | ACTIVE | CLGA | FLS | 355 | 1 | RoHS & Green | NI-PD-AU | N / A for Pkg Type | | | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

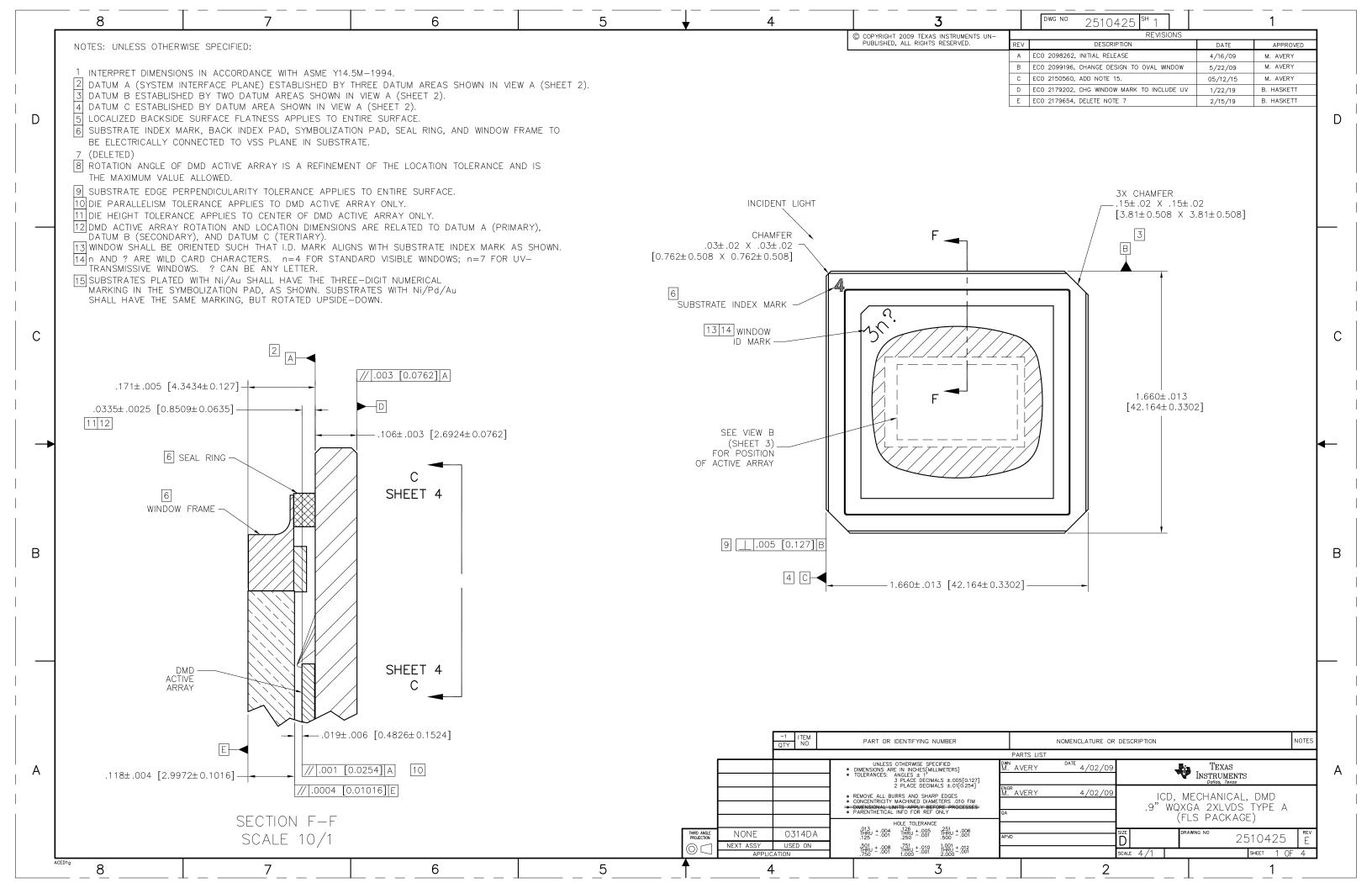
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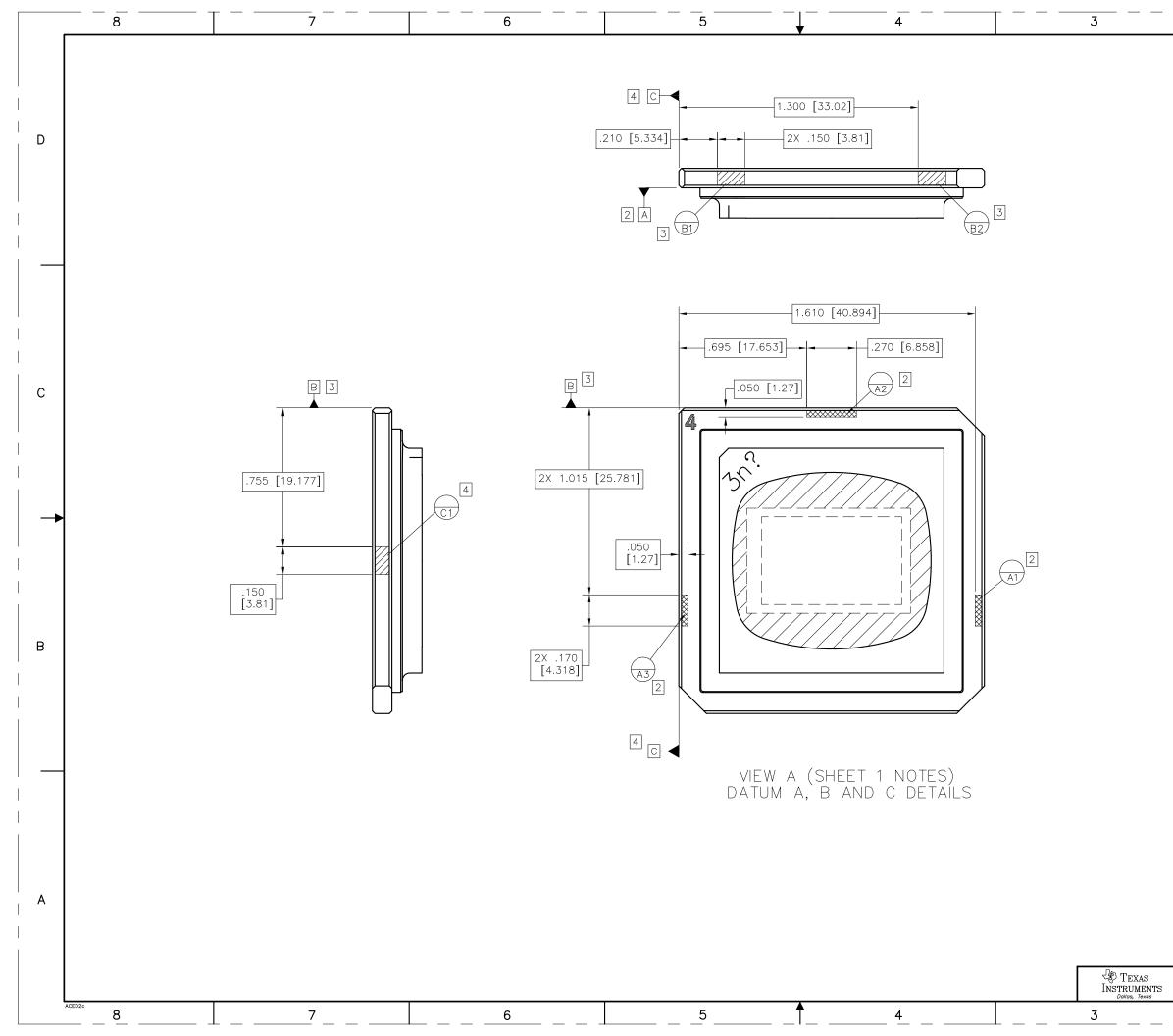
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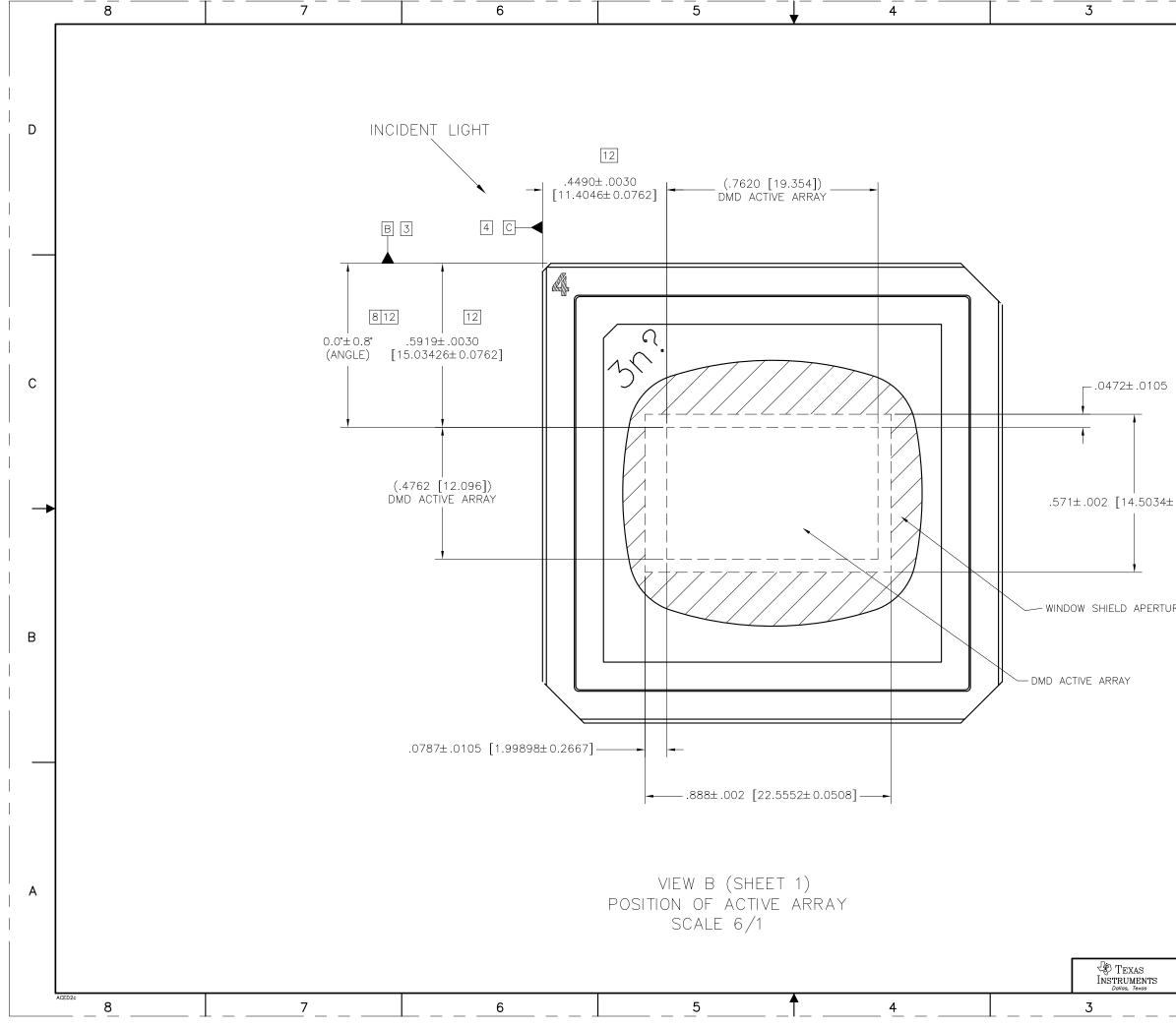
PACKAGE OPTION ADDENDUM

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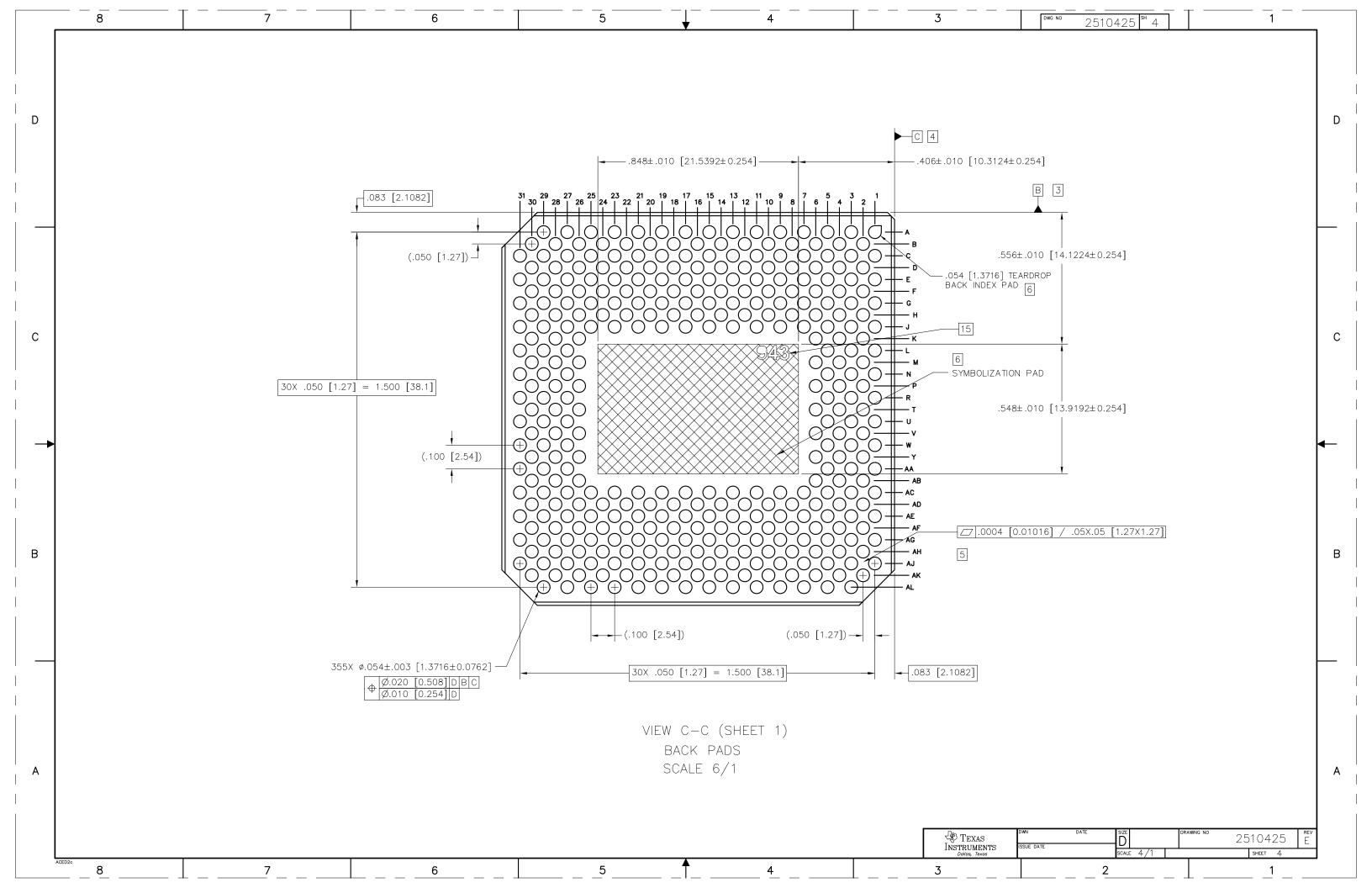




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